

CDM MIAMI INC

GSM PHONE

Model: T8

Series Model:T10, T10L, X5, X9

Sep 14th 2011

Report No.: 11070072-SAR(FCC)

(This report supersedes NONE)



Modifications made to the product : None

This Test Report is Issued Under the Authority of:

David Zhang Compliance Engineer	Leslie Bai Director of Certification

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All Test Data Presented in this report is only applicable to presented Test sample.





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Accreditations for Product Certifications

Country	Accreditation Body	Scope
USA	FCC TCB, NIST	EMC , RF , Telecom
Canada	IC FCB , NIST	EMC , RF , Telecom
Singapore	iDA, NIST	EMC , RF , Telecom
EU	NB, NIST	EMC,RF,Safety,Telecom



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Model : T8

To C95.1, IEEE 1528, OET Bulletin 65 Supplement C, IEC62209-2 & RSS-102
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1 Executive Summary & EUT information

The purpose of this test programmed was to demonstrate compliance of the CDM Miami Inc Model: T8 against the current Stipulated Standards. The Mobile Computer have demonstrated compliance with the C95.1, IEEE 1528, OET Bulletin 65 Supplement C , IEC62209-2, RSS-102 Issue 4 and Safety Code 6. The test has demonstrated that this unit complies with stipulated standards.

EUT Information

EUT	: Mobile Phone
Description	
Model No	: T8, T10, T10L, X5, X9
Serial No	: N/A
Input Power	: 3.6V-4.2VDC
Maximum Output Power to Antenna	GSM850(Class 4) : 1.923 W (32.84dBm) GSM1900 (Class 1) : 0.771W (28.87dBm)
Max. SAR Level(s) Measured	0.645 W/Kg 1g Head Tissue (Cellular Band) 0.559 W/Kg 1g Body Tissue (Cellular Band) 0.180 W/Kg 1g Head Tissue (PCS Band) 0.072 W/Kg 1g Body Tissue (PCS Band)
Classification	
Per Stipulated Test Standard	: Mobile Device , Class B
Co-located TX Antenna Separation distances	: WWAN can transmit simultaneously with Bluetooth : 7.7 cm - WWAN antenna-to-Bluetooth antenna
Antenna Type(s)	: Internal Antenna

Note: All models are the same, except the colour. So we select the model: T8 to test. Please refer to the product similarly letter

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2 TECHNICAL DETAILS

Purpose	Compliance testing of Mobile Phone model T8 with stipulated standard
Applicant / Client	CDM Miami Inc 1825 NW 112 AVE Unit 158, Miami, FL 33172, USA
Manufacturer	CDM Miami Inc 1825 NW 112 AVE Unit 158, Miami, FL 33172, USA
Laboratory performing the tests	SIEMIC Laboratories 2206 Ringwood Ave San Jose, CA95131 United States
Test report reference number	11070072-SAR
Date EUT received	Sep 1 th 2011
Standard applied	See Page 9
Dates of test (from – to)	Sep 14 th 2011
No of Units:	1
Equipment Category:	PCE
Trade Name:	OLA, FUN
Model Name:	T8, T10, T10L, X5, X9
RF Operating Frequency (ies)	GSM850 : 824.2 ~ 848.8 MHz(TX) / 869.2 ~ 893.8 MHz(RX) GSM1900 : 1850.2 ~ 1909.8 MHz(TX) / 1930.2 ~ 1989.8 MHz(RX) BT:2402~ 2480MHz(TX/RX)
Modulation:	GSM : GMSK Bluetooth: GFSK
FCC ID	ZZRTM025
IC ID:	N/A



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3 INTRODUCTION

Introduction

This measurement report shows compliance of the EUT with FCC OET Bulletin 65 Supplement C (Edition 01-01), IEC 62209-2 & RSS 102 Issue 4.0.

The test procedures, as described in ANSI C95.1 – 1999 Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3 kHz to 300 GHz [2], and ANSI C95.3 – 2002 Recommended Practice for the Measurement of Potentially Hazardous Electromagnetic Fields [3], were employed.

SAR Definition

Specific Absorption Rate is defined as the time derivative (rate) of the incremental energy (dW) absorbed by (dissipated in) an incremental mass (dm) contained in a volume element (dV) of a given density (ρ).

$$SAR = \frac{d}{dt} \left(\frac{dW}{dm} \right) = \frac{d}{dt} \left(\frac{dW}{\rho dV} \right)$$

SAR is expressed in units of watts per kilogram (W/kg). SAR can be related to the electric field at a point by

$$SAR = \frac{\sigma |E|^2}{\rho}$$

where:

σ = conductivity of the tissue (S/m)

ρ = mass density of the tissue (kg/m³)

E = rms electric field strength (V/m)



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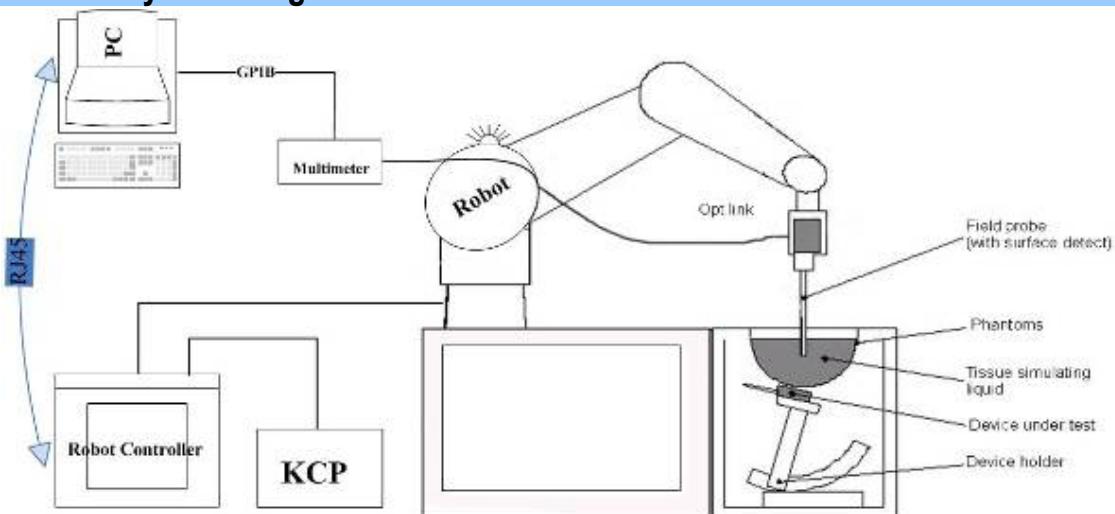
4 SAR Measurement Setup

Dosimetric Assessment System

These measurements were performed with the automated near-field scanning system OPENSAR from SATIMO. The system is based on a high precision robot (working range: 850 mm), which positions the probes with a positional repeatability of better than ± 0.02 mm. Special E- and H-field probes have been developed for measurements close to material discontinuity, the sensors of which are directly loaded with a Schottky diode and connected via highly resistive lines to the data acquisition unit.

The SAR measurements were conducted with dosimetric probe (manufactured by SATIMO), designed in the classical triangular configuration and optimized for dosimetric evaluation. The probe has been calibrated according to the procedure described in SAR standard with accuracy of better than $\pm 10\%$. The spherical isotropy was evaluated with the procedure described in SAR standard and found to be better than ± 0.25 dB. The phantom used was the SAM Phantom as described in FCC supplement C, IEEE P1528 and CENELEC EN62209-1.

Measurement System Diagram



The OPENSAR system for performing compliance tests consist of the following items:

1. A standard high precision 6-axis robot (KUKA) with controller and software.
2. KUKA Control Panel (KCP).
3. A dosimetric probe, i.e., an isotropic E-field probe optimized and calibrated for usage in tissue simulating liquid. The probe is equipped with an optical surface detector system.
4. The functions of the PC plug-in card are to perform the time critical task such as signal filtering, surveillance of the robot operation fast movement interrupts.



5. A computer operating Windows XP.
6. OPENSAR software.
7. Remote control with teaches pendant and additional circuitry for robot safety such as warning lamps, etc.
8. The SAM phantom enabling testing left-hand right-hand and body usage.
9. The Position device for handheld EUT.
10. Tissue simulating liquid mixed according to the given recipes (see Application Note).
11. System validation dipoles to validate the proper functioning of the system.



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EP100 Probe



Construction Symmetrical design with triangular Core. Built-in shielding against static charges Calibration in air from 100 MHz to 2.5 GHz. In brain and muscle simulating tissue at frequencies from 800 to 6000 MHz (accuracy of 8%) .

Frequency 100 MHz to 6 GHz;

Linearity ; 0.25 dB (100 MHz to 6 GHz) ,

Directivity : 0.25 dB in brain tissue (rotation around probe axis) 0.5 dB in brain tissue (rotation normal probe axis)

Dynamic : 0.001W/kg to > 100W/kg;

Range Linearity: 0.25 dB

Surface : 0.2 mm repeatability in air and liquids

Dimensions Overall length: 330 mm

Tip length: 16 mm

Body diameter: 8 mm

Tip diameter: 2.6 mm

Distance from probe tip to dipole centers: <1.5 mm

Application General dosimetric up to 6 GHz

Compliance tests of mobile phones

Fast automatic scanning in arbitrary phantoms

The SAR measurements were conducted with the dosimetric probe designed in the classical triangular configuration and optimized for dosimetric evaluation. The probe is constructed using the thick film technique, with printed resistive lines on ceramic substrates.



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It is connected to the KRC box on the robot arm and provides an automatic detection of the phantom surface. The 3D file of the phantom is included in OpenSAR software. The Video Positioning System allows the system to take the automatic reference and to move the probe safely and accurately on the phantom.

E-Field Probe Calibration Process

Each probe is calibrated according to a dosimetric assessment procedure described in SAR standard with accuracy better than +/- 10%. The spherical isotropy was evaluated with the procedure described in SAR standard and found to be better than +/-0.25dB. The sensitivity parameters (NormX, NormY, NormZ), the diode compression parameter (DCP) and the conversion factor (ConvF) of the probe are tested.

The free space E-field from probe outputs is determined in a test chamber. This is performed in a TEM cell for frequencies below 0.8 GHz, and in a waveguide above 0.8 GHz for free space. For the free space calibration, the probe is placed in the volumetric center of the cavity and at the proper orientation with the field. E-field correlation calibration is performed in a flat phantom filled with the appropriate simulated brain tissue.

SAM Phantom

The SAM Phantom SAM29 is constructed of a fiberglass shell integrated in a wooden table. The shape of the shell is in compliance with the specification set in IEEE P1528 and CENELEC EN62209-1, IEC62209-2. The phantom enables the dosimetric evaluation of left and right hand phone usage as well as body mounted usage at the flat phantom region.

A cover prevents the evaporation of the liquid.

Reference markings on the Phantom allow the complete setup of all predefined phantom positions and measurement grids by manually teaching three points in the robot.

Shell Thickness: 2 0.2 mm

Filling Volume: Approx. 25 liters

Dimensions (H x L x W): 810 x 1000 x 500 mm

Liquid is filled to at least 15mm from the bottom of Phantom.





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Device Holder

In combination with the Generic Twin Phantom V3.0, the Mounting Device enables the rotation of the mounted transmitter in spherical coordinates whereby the rotation points is the ear opening. The devices can be easily, accurately, and repeatedly positioned according to the FCC and CENELEC specifications. The device holder can be locked at different phantom locations (left head, right head, flat phantom).



Note: A simulating human hand is not used due to the complex anatomical and geometrical structure of the hand that may produced infinite number of configurations [10]. To produce the worst-case condition (the hand absorbs antenna output power), the hand is omitted during the tests.

Data Evaluation

The OPENSAR software automatically executes the following procedure to calculate the field units from the microvolt readings at the probe connector. The parameters used in the valuation are stored in the configuration modules of the software:

Probe Parameters	- Sensitivity	Norm _i
	- Conversion factor	ConvFi
	- Diode compression point Dcp _i	
Device Parameter	- Frequency	f
	- Crest factor	cf
Media Parametrs	- Conductivity	σ
	- Density	ρ

These parameters must be set correctly in the software. They can either be found in the component documents or be imported into the software from the configuration files issued for the OPENSAR components.

The first step of the evaluation is a linearization of the filtered input signal to account for the compression characteristics of the detector diode. The compensation depends on the input signal, the diode type and the DC-transmission factor from the diode to the evaluation electronics. If the exciting field is pulsed, the crest factor of the signal must be known to correctly compensate for peak power. The formula for each channel can be given as

$$V_i = U_i + U_i^2 \cdot \frac{cf}{dcpi}$$

Where V_i = Compensated signal of channel i ($i = x, y, z$)

U_i = Input signal of channel i ($i = x, y, z$)

cf = Crest factor of exciting field (DASY parameter)

$dcpi$ = Diode compression point (DASY parameter)



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From the compensated input signals the primary field data for each channel can be evaluated:

$$\text{E-field probes: } E_i = \sqrt{\frac{V_i}{\text{Norm}_i \cdot \text{ConvF}}}$$

$$\text{H-field probes: } H_i = \sqrt{V_i} \cdot \frac{a_{i0} + a_{i1}f + a_{i2}f^2}{f}$$

Where V_i = Compensated signal of channel i ($i = x, y, z$)

Norm_i = Sensor sensitivity of channel i ($i = x, y, z$)
 $\mu\text{V}/(\text{V}/\text{m})^2$ for E-field Probes

ConvF = Sensitivity enhancement in solution

a_{ij} = Sensor sensitivity factors for H-field probes

f = Carrier frequency (GHz)

E_i = Electric field strength of channel i in V/m

H_i = Magnetic field strength of channel i in A/m

The RSS value of the field components gives the total field strength (Hermitian magnitude):

$$E_{\text{tot}} = \sqrt{E_x^2 + E_y^2 + E_z^2}$$

The primary field data are used to calculate the derived field units.

$$\text{SAR} = E_{\text{tot}}^2 \cdot \frac{\sigma}{\rho \cdot 1000}$$

where SAR = local specific absorption rate in mW/g

E_{tot} = total field strength in V/m

σ = conductivity in [mho/m] or [siemens/m]

ρ = equivalent tissue density in g/cm³

Note that the density is normally set to 1 (or 1.06), to account for actual brain density rather than the density of the simulation liquid.

The power flow density is calculated assuming the excitation field as a free space field.

$$P_{\text{pwe}} = \frac{E_{\text{tot}}^2}{3770} \quad \text{or} \quad P_{\text{pwe}} = H_{\text{tot}}^2 \cdot 37.7$$

where P_{pwe} = Equivalent power density of a plane wave in mW/cm²

E_{tot} = total electric field strength in V/m

H_{tot} = total magnetic field strength in A/m



SAR Evaluation – Peak Spatial - Average

The procedure for assessing the peak spatial-average SAR value consists of the following steps

- **Power Reference Measurement**

The reference and drift jobs are useful jobs for monitoring the power drift of the device under test in the batch process. Both jobs measure the field at a specified reference position, at a selectable distance from the phantom surface. The reference position can be either the selected section's grid reference point or a user point in this section. The reference job projects the selected point onto the phantom surface, orients the probe perpendicularly to the surface, and approaches the surface using the selected detection method.

- **Area Scan**

The area scan is used as a fast scan in two dimensions to find the area of high field values, before doing a finer measurement around the hot spot. The sophisticated interpolation routines implemented in OPENSAR software can find the maximum locations even in relatively coarse grids. The scan area is defined by an editable grid. This grid is anchored at the grid reference point of the selected section in the phantom. When the area scan's property sheet is brought-up, grid was at to 15 mm by 15 mm and can be edited by a user.

- **Zoom Scan**

Zoom scans are used to assess the peak spatial SAR values within a cubic averaging volume containing 1 g and 10 g of simulated tissue. The default zoom scan measures 5 x 5 x 7 points within a cube whose base faces are centered around the maximum found in a preceding area scan job within the same procedure. If the preceding Area Scan job indicates more than one maximum, the number of Zoom Scans has to be enlarged accordingly (The default number inserted is 1).

- **Power Drift measurement**

The drift job measures the field at the same location as the most recent reference job within the same procedure, and with the same settings. The drift measurement gives the field difference in dB from the reading conducted within the last reference measurement. Several drift measurements are possible for one reference measurement. This allows a user to monitor the power drift of the device under test within a batch process. In the properties of the Drift job, the user can specify a limit for the drift and have OPENSAR software stop the measurements if this limit is exceeded.

SAR Evaluation – Peak SAR

The procedure for spatial peak SAR evaluation has been implemented according to the IEEE1529 standard. It can be conducted for 1 g and 10 g. The OPENSAR system allows evaluations that combine measured data and robot positions, such as:

- maximum search
- extrapolation
- boundary correction
- peak search for averaged SAR

During a maximum search, global and local maximum searches are automatically performed in 2-D after each Area Scan measurement with at least 6 measurement points. It is based on the evaluation of the local SAR gradient calculated by the Quadratic Shepard's method. The algorithm will find the global maximum and all local maxima within -2 dB of the global maxima for all SAR distributions.

Extrapolation

Extrapolation routines are used to obtain SAR values between the lowest measurement points and the inner phantom surface. The extrapolation distance is determined by the surface detection distance and the probe sensor offset. Several measurements at different distances are necessary for the extrapolation.

They are used in the Cube Scan to obtain SAR values between the lowest measurement points and the inner phantom surface. The routine uses the fourth order least square polynomial method for extrapolation. For a grid using 5x5x7 measurement points with 5mm resolution amounting to 343 measurement points, the uncertainty of the extrapolation routines is less than 1% for 1 g and 10 g cubes.

Definition of Reference Points

Ear Reference Point

Figure 6.2 shows the front, back and side views of the SAM Phantom. The point "M" is the reference point for the center of the mouth, "LE" is the left ear reference point (ERP), and "RE" is the right ERP. The ERPs are 15mm posterior to the entrance to the ear canal (EEC) along the B-M line (Back-Mouth), as shown in Figure 6.1. The plane passing through the two ear canals and M is defined as the Reference Plane. The line N-F (Neck-Front) is perpendicular to the reference plane and passing through the RE (or LE) is called the Reference Pivoting Line (see Figure 6.1). Line B-M is perpendicular to the N-F line. Both N-F and B-M lines are marked on the external phantom shell to facilitate handset positioning [5].

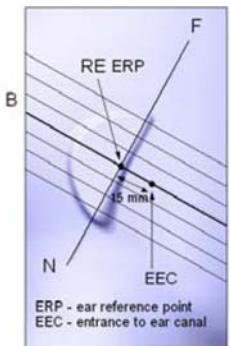


Figure 6.1 Close-up side view of ERP's



Figure 6.2 Front, back and side view of SAM

Device Reference Points

Two imaginary lines on the device need to be established: the vertical centerline and the horizontal line. The test device is placed in a normal operating position with the "test device reference point" located along the "vertical centerline" on the front of the device aligned to the "ear reference point" (See Fig. 6.3). The "test device reference point" is then located at the same level as the center of the ear reference point. The test device is positioned so that the "vertical centerline" is bisecting the front surface of the device at its top and bottom edges, positioning the "ear reference point" on the outer surface of both the left and right head phantoms on the ear reference point [5].

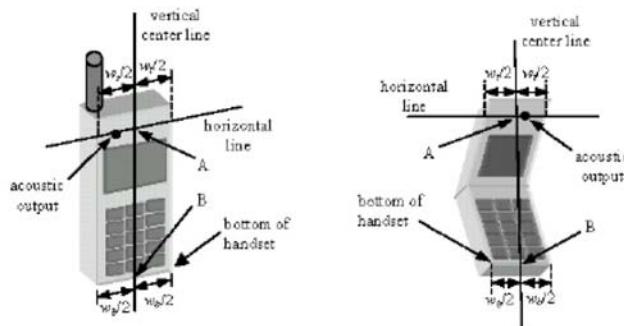


Figure 6.3 Handset Vertical Center & Horizontal Line Reference Points



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Test Configuration – Positioning for Cheek / Touch

1. Position the device close to the surface of the phantom such that point A is on the (virtual) extension of the line passing through points RE and LE on the phantom (see Figure below), such that the plane defined by the vertical center line and the horizontal line of the device is approximately parallel to the sagittal plane of the phantom

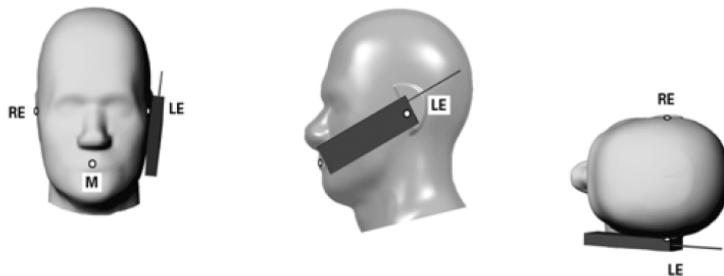


Figure 7.1 Front, Side and Top View of Cheek/Touch Position

2. Translate the device towards the phantom along the line passing through RE and LE until the device touches the ear.
3. While maintaining the device in this plane, rotate it around the LE-RE line until the vertical centerline is in the plane normal to MB-NF including the line MB (called the reference plane).
4. Rotate the device around the vertical centerline until the device (horizontal line) is symmetrical with respect to the line NF.
5. While maintaining the vertical centerline in the reference plane, keeping point A on the line passing through RE and LE and maintaining the device contact with the ear, rotate the device about the line NF until any point on the device is in contact with a phantom point below the ear (cheek). See Figure below.

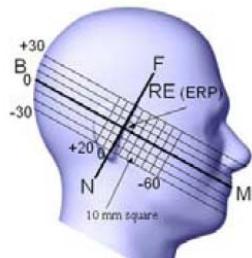


Figure 7.2 Side view w/ relevant markings



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Test Configuration – Positioning for Ear / 15° Tilt

With the test device aligned in the Cheek/Touch Position":

1. While maintaining the orientation of the device, retracted the device parallel to the reference plane far enough to enable a rotation of the device by 15 degrees.
2. Rotate the device around the horizontal line by 15 degrees.
3. While maintaining the orientation of the device, move the device parallel to the reference plane until any part of the device touches the head. (In this position, point A is located on the line RE-LE). The tilted position is obtained when the contact is on the pinna. If the contact is at any location other than the pinna, the angle of the device shall be reduced. The tilted position is obtained when any part of the device is in contact with the ear as well as a second part of the device is in contact with the head (see Figure below).

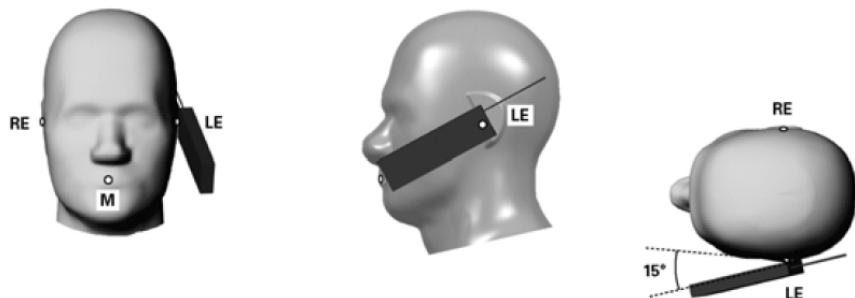
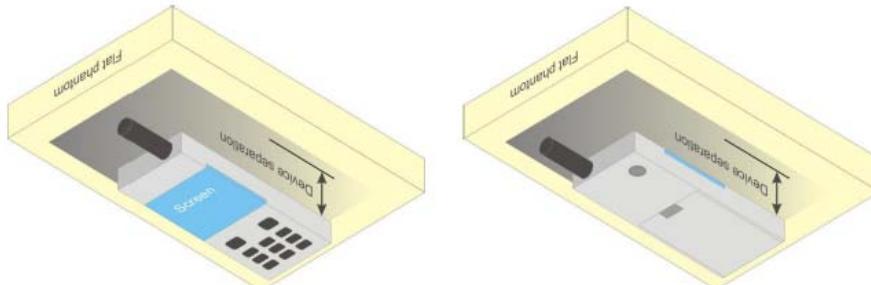


Figure 7.3 Front, Side and Top View of Ear/15° Tilt Position

Test Position – Body Worn Configurations

Body Worn Position

- (a) To position the device parallel to the phantom surface with either keypad up or down.
- (b) To adjust the device parallel to the flat phantom.
- (c) To adjust the distance between the device surface and the flat phantom to 1.5 cm or holster surface and the flat phantom to 0 cm.





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5 ANSI/IEEE C95.1 – 1999 RF Exposure Limit

In order for users to be aware of the body-worn operating requirements for meeting RF exposure compliance, operating instructions and cautions statements are included in the user's manual.

Uncontrolled Environment

Uncontrolled Environments are defined as locations where there is the exposure of individuals who have no knowledge or control of their exposure. The general population/uncontrolled exposure limits are applicable to situations in which the general public may be exposed or in which persons who are exposed as a consequence of their employment may not be made fully aware of the potential for exposure or cannot exercise control over their exposure. Members of the general public would come under this category when exposure is not employment-related; for example, in the case of a wireless transmitter that exposes persons in its vicinity.

Controlled Environment

Controlled Environments are defined as locations where there is exposure that may be incurred by persons who are aware of the potential for exposure, (i.e. as a result of employment or occupation). In general, occupational/controlled exposure limits are applicable to situations in which persons are exposed as a consequence of their employment, who have been made fully aware of the potential for exposure and can exercise control over their exposure. This exposure category is also applicable when the exposure is of a transient nature due to incidental passage through a location where the exposure levels may be higher than the general population/uncontrolled limits, but the exposed person is fully aware of the potential for exposure and can exercise control over his or her exposure by leaving the area or by some other appropriate means.

Table 8.1 Human Exposure Limits

	UNCONTROLLED ENVIRONMENT General Population (W/kg) or (mW/g)	CONTROLLED ENVIRONMENT Professional Population (W/kg) or (mW/g)
SPATIAL PEAK SAR ¹ Brain	1.60	8.00
SPATIAL AVERAGE SAR ² Whole Body	0.08	0.40
SPATIAL PEAK SAR ³ Hands, Feet, Ankles, Wrists	4.00	20.00

¹ The Spatial Peak value of the SAR averaged over any 1 gram of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.

² The Spatial Average value of the SAR averaged over the whole body.

³ The Spatial Peak value of the SAR averaged over any 10 grams of tissue (defined as a tissue volume in the shape of a cube) and over the appropriate averaging time.



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Model : T8

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6 SYSTEM AND LIQUID VALIDATION

System Validation

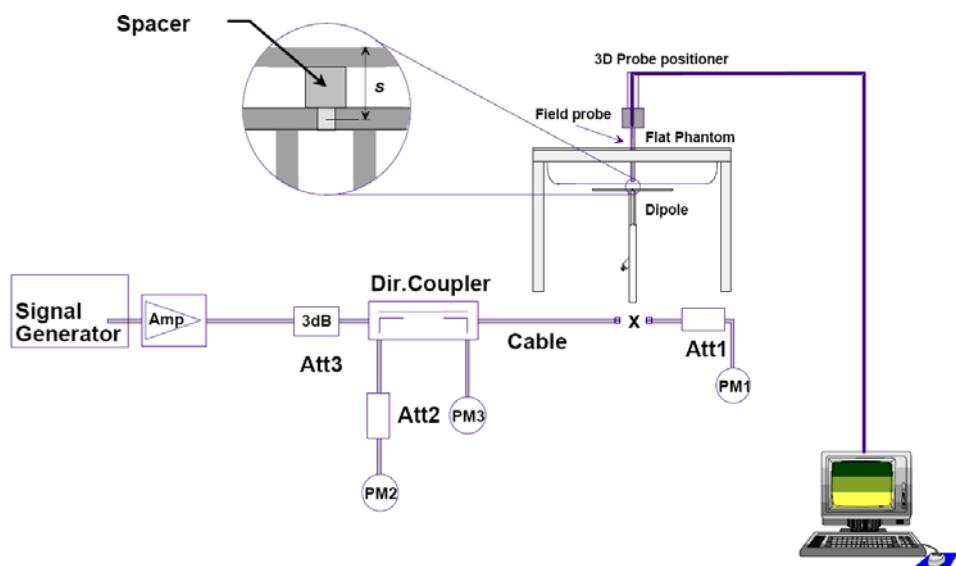


Fig 8.1 System Setup for System Evaluation

The system performance check verifies that the system operates within its specifications. System and operator errors can be detected and corrected. It is recommended that the system performance check be performed prior to any usage of the system in order to guarantee reproducible results. The system performance check uses normal SAR measurements in a simplified setup with a well characterized source. This setup was selected to give a high sensitivity to all parameters that might fail or vary over time. The system check does not intend to replace the calibration of the components, but indicates situations where the system uncertainty is exceeded due to drift or failure.

In the simplified setup for system evaluation, the DUT is replaced by a calibrated dipole and the power source is replaced by a continuous wave that comes from a signal generator. The calibrated dipole must be placed beneath the flat phantom section of the SAM twin phantom with the correct distance holder. The distance holder should touch the phantom surface with a light pressure at the reference marking and be oriented parallel to the long side of the phantom. The equipment setup is shown below:

1. Signal Generator
2. Amplifier
3. Directional Coupler
4. Power Meter
5. Calibrated Dipole

The output power on dipole port must be calibrated to 30 dBm (1000 mW) before dipole is connected.



Numerical reference SAR values (W/kg) for reference dipole and flat phantom

Frequency (MHz)	1 g SAR	10 g SAR	Local SAR at surface (above feed-point)	Local SAR at surface (y = 2 cm offset from feed-point) ^a
300	3.0	2.0	4.4	2.1
450	4.9	3.3	7.2	3.2
835	9.5	6.2	4.1	4.9
900	10.8	6.9	16.4	5.4
1450	29.0	16.0	50.2	6.5
1800	38.1	19.8	69.5	6.8
1900	39.7	20.5	72.1	6.6
2000	41.1	21.1	74.6	6.5
2450	52.4	24.0	104.2	7.7
3000	63.8	25.7	140.2	9.5

Target and measurement SAR after Normalized

Measurement Date	Frequency (MHz)	Liquid Type (head/body)	Target SAR1g (W/kg)	Measured SAR1g (W/kg)	Deviation (%)
Sep 14 th ,2011	835	head	9.5	9.2	-3.15
Sep 14 th ,2011	835	body	9.5	9.8	+3.15
Sep 14 th ,2011	1900	head	39.7	38.2	-3.77
Sep 14 th ,2011	1900	body	39.7	39.2	-1.25



Liquid Validation

The dielectric parameters were checked prior to assessment using the HP85070C dielectric probe kit. The dielectric parameters measured are reported in each correspondent section.

IEEE SCC-34/SC-2 P1528 recommended Tissue Dielectric Parameters

The head tissue dielectric parameters recommended by the IEEE SCC-34/SC-2 in P1528 have been incorporated in the following table. These head parameters are derived from planar layer models simulating the highest expected SAR for the dielectric properties and tissue thickness variations in a human head. Other head and body tissue parameters that have not been specified in P1528 are derived from the tissue dielectric parameters computed from the 4-Cole-Cole equations and extrapolated according to the head parameters specified in P1528

Target Frequency	Head		Body		
	MHz	ϵ_r	σ (S/m)	ϵ_r	σ (S/m)
150		52.3	0.76	61.9	0.80
300		45.3	0.87	58.2	0.92
450		43.5	0.87	56.7	0.94
835		41.5	0.90	55.2	0.97
900		41.5	0.97	55.0	1.05
915		41.5	0.98	55.0	1.06
1450		40.5	1.20	54.0	1.30
1610		40.3	1.29	53.8	1.40
1800-2000		40.0	1.40	53.3	1.52
2450		39.2	1.80	52.7	1.95
3000		38.5	2.40	52.0	2.73
5800		35.3	5.27	48.2	6.00

Note: ϵ_r = relative permittivity, σ = conductivity and $\rho = 1000 \text{ kg/m}^3$



Liquid Confirmation Result:

Temperature: <u>22°C</u>			Relative humidity: <u>53%</u>		
Freq(MHz)		Target	Measured	Deviation (%)	Limit (%)
835	Head	Permittivity	41.5	41.578	-0.19
		Conductivity	0.90	0.8980	-0.20
835	Body	Permittivity	55.2	55.096	0.19
		Conductivity	0.97	0.9740	-0.31
848.8	Head	Permittivity	41.5	41.588	0.21
		Conductivity	0.90	0.8987	0.14
848.8	Body	Permittivity	55.2	55.101	-0.17
		Conductivity	0.97	0.9752	0.53

Temperature: <u>22 °C</u>			Relative humidity: <u>53%</u>		
Freq(MHz)		Target	Measured	Deviation (%)	Limit (%)
1900	Head	Permittivity	40.00	41.215	3.04
		Conductivity	1.4	1.386	-1.07
1900	Body	Permittivity	53.3	53.547	0.46
		Conductivity	1.52	1.533	0.79
1850.2	Head	Permittivity	40.00	41.225	3.06
		Conductivity	1.4	1.387	-0.92
1850.2	Body	Permittivity	53.3	53.557	0.48
		Conductivity	1.52	1.534	0.92

Note: The liquid validation was performed at Sep 14th 2011.

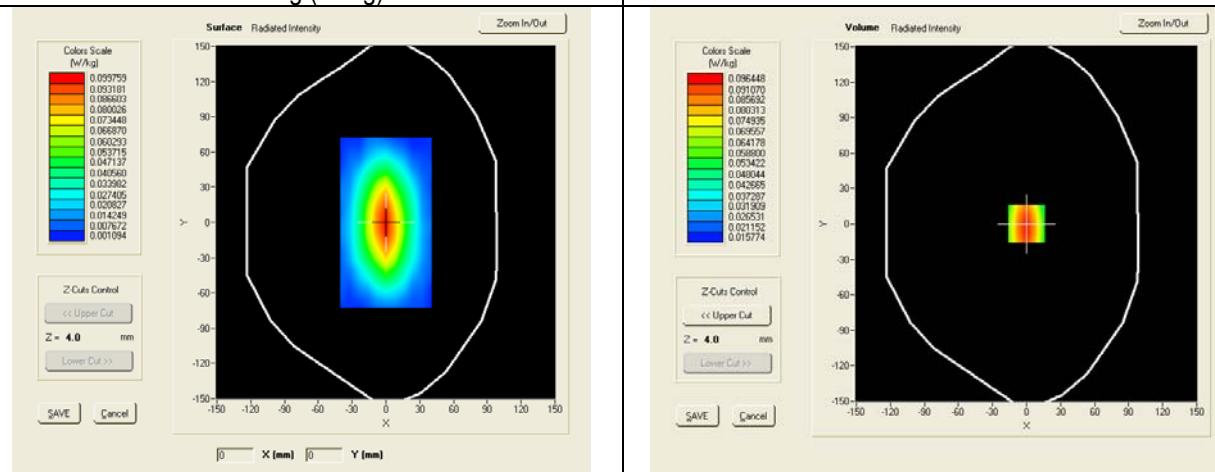
System Validation Plots

Product Description: Mobile Phone

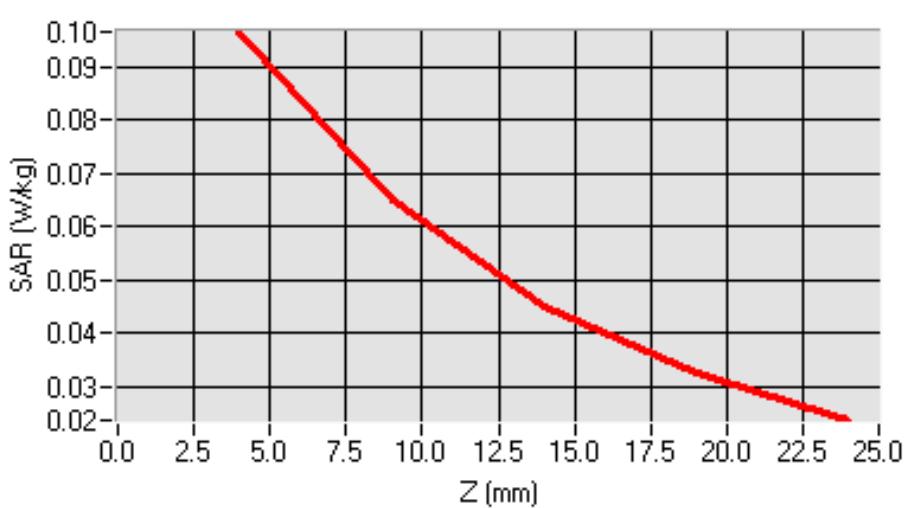
Model: T8

Test Date: Sep 14th 2011

Frequency (MHz)	835.000000 (Head)
Relative permittivity (real part)	41.5780
Conductivity (S/m)	0.8980
Input power	10mW
Crest factor	1.0
Conversion Factor	6.04
Variation (%)	-1.120000
SAR 10g (W/Kg)	0.060
SAR 1g (W/Kg)	0.092



SAR, Z Axis Scan ($X = 0, Y = 0$)



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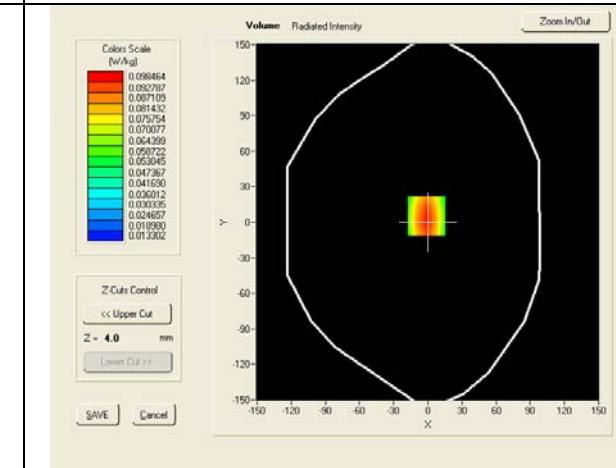
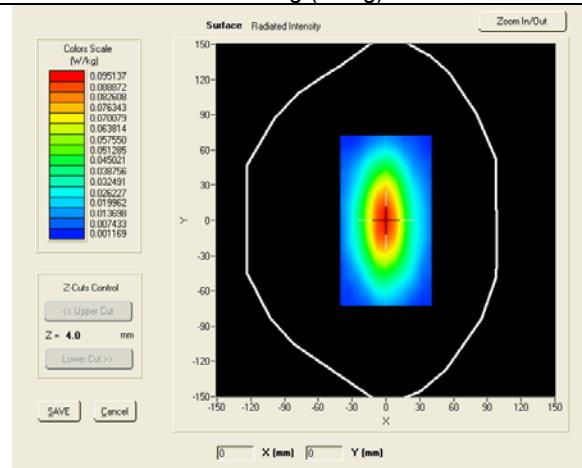
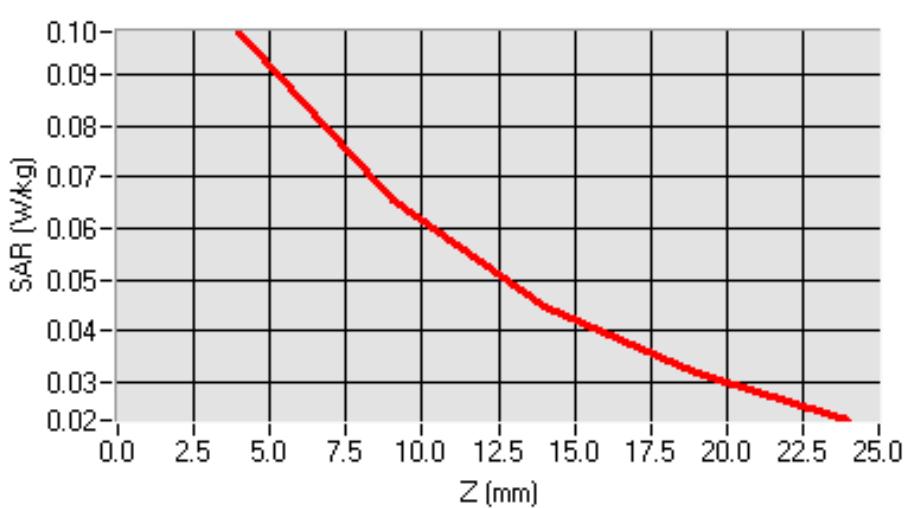
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Product Description: Mobile Phone**Model: T8****Test Date: Sep 14th 2011**

Frequency (MHz)	835.000000 (Body)
Relative permittivity (real part)	55.096
Conductivity (S/m)	0.9740
Input power	10mW
Crest factor	1.0
Conversion Factor	6.21
Variation (%)	-1.630000
SAR 10g (W/Kg)	0.064
SAR 1g (W/Kg)	0.098

**SAR, Z Axis Scan (X = -1, Y = 5)**

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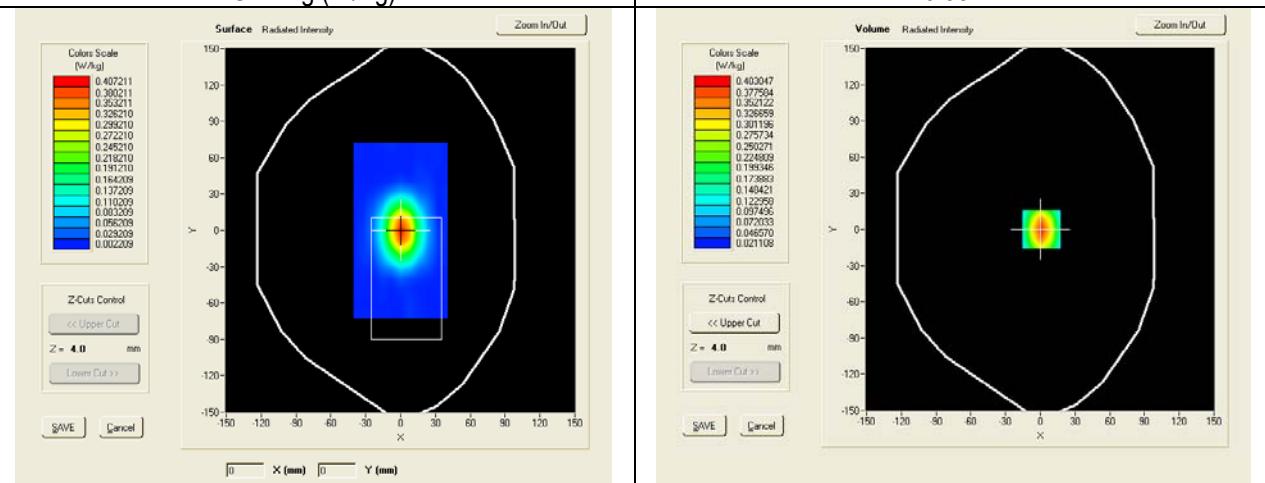
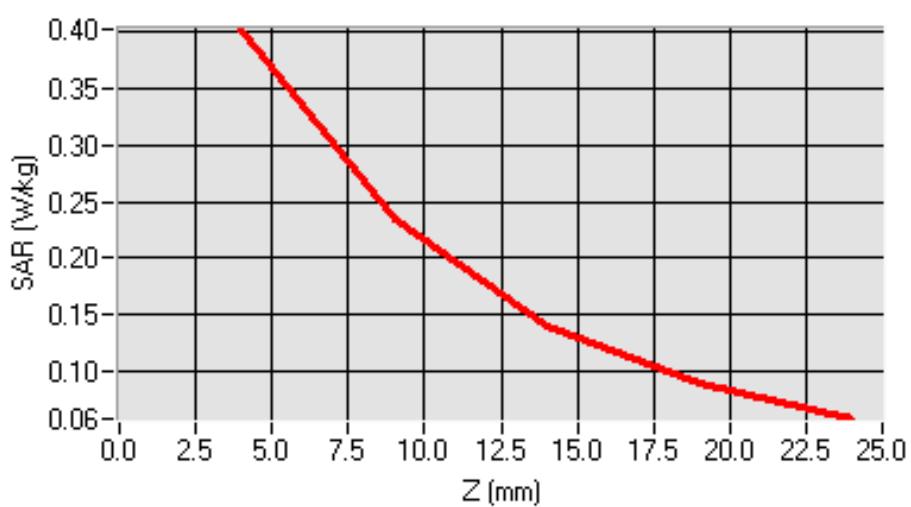
Issue Date Sep 14th 2011

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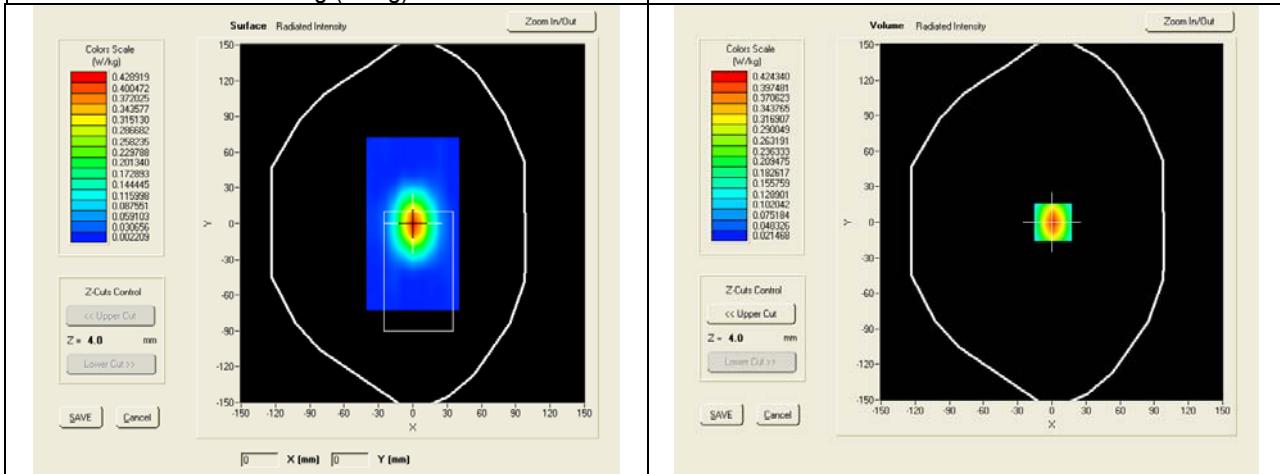
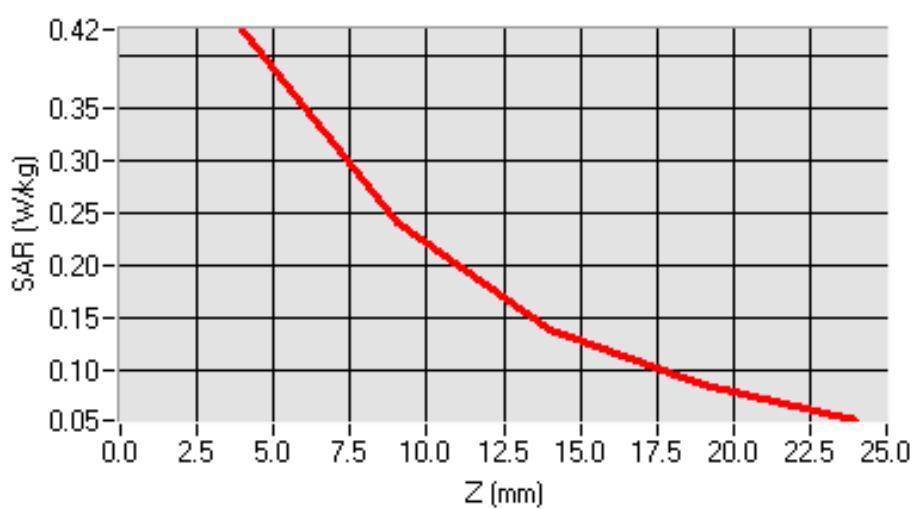
Product Description: Mobile Phone**Model:** T8**Test Date:** Sep 14th 2011

Frequency (MHz)	1900.00000(Head)
Relative permitivity (real part)	41.215
Conductivity (S/m)	1.386
Input power	10mW
Crest factor	1.0
Conversion Factor	6.18
Variation (%)	0.1200000
SAR 10g (W/Kg)	0.201
SAR 1g (W/Kg)	0.382

**SAR, Z Axis Scan ($X = 1$, $Y = 0$)**

Product Description: Mobile Phone**Model: T8****Test Date: Sep 14th 2011**

Frequency (MHz)	1900.000000(Body)
Relative permittivity (real part)	53.547
Conductivity (S/m)	1.533
Input power	10mW
Crest factor	1.0
Conversion Factor	6.38
Variation (%)	0.120
SAR 10g (W/Kg)	0.209
SAR 1g (W/Kg)	0.392

**SAR, Z Axis Scan (X = 1, Y = 0)**



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7 TYPE A MEASUREMENT UNCERTAINTY

The component of uncertainty may generally be categorized according to the methods used to evaluate them. The evaluation of uncertainty by the statistical analysis of a series of observations is termed a Type A evaluation of uncertainty. The evaluation of uncertainty by means other than the statistical analysis of a series of observation is termed a Type B evaluation of uncertainty. Each component of uncertainty, however evaluated, is represented by an estimated standard deviation, termed standard uncertainty, which is determined by the positive square root of the estimated variance

A Type A evaluation of standard uncertainty may be based on any valid statistical method for treating data. This includes calculating the standard deviation of the mean of a series of independent observations; using the method of least squares to fit a curve to the data in order to estimate the parameter of the curve and their standard deviations; or carrying out an analysis of variance in order to identify and quantify random effects in certain kinds of measurement.

A type B evaluation of standard uncertainty is typically based on scientific judgment using all of the relevant information available. These may include previous measurement data, experience and specification, data provided in calibration reports and uncertainties assigned to reference data taken from handbooks. Broadly speaking, the uncertainty is either obtained from an outdoor source or obtained from an assumed distribution, such as the normal distribution, rectangular or triangular distributions indicated in Table below :

Uncertainty Distribution	Normal	Rectangle	Triangular	U Shape
Multi-plying Factor ^(a)	$1/k^{(b)}$	$1/\sqrt{3}$	$1/\sqrt{6}$	$1/\sqrt{2}$

(a) standard uncertainty is determined as the product of the multiplying factor and the estimated range of variations in the measured quantity

(b) k is the coverage factor

Standard Uncertainty for Assumed Distribution

The combined standard uncertainty of the measurement result represents the estimated standard deviation of the result. It is obtained by combining the individual standard uncertainties of both Type A and Type -sum-by taking the positive square root of the estimated variances.

Expanded uncertainty is a measure of uncertainty that defines an interval about the measurement result within which the measured value is confidently believed to lie. It is obtained by multiplying the combined standard uncertainty by a coverage factor. Typically, the coverage factor ranges from 2 to 3. Using a coverage factor allows the true value of a measured quantity to be specified with a defined probability within the specified uncertainty range. For purpose of this document, a coverage factor two is used, which corresponds to confidence interval of about 95 %.

The COMOSAR Uncertainty Budget is show in below table :



Uncertainty Budget of COMOSAR for frequency range 300 MHz to 6 GHz

Uncertainty Component	Tolerances %	Probability Distribution	Divisor	Ci (1g)	Ci (10g)	Uncertainty 1g(%)	Uncertainty 10g(%)
Measurement System Related							
Probe Calibration	6	N	1	1	1	6	6
Axial Isotropy	3	R	$\sqrt{3}$	$\sqrt{(1-C_p)}$	$\sqrt{(1-C_p)}$	1.22474	1.22474
Hemispherical Isotropy	4	R	$\sqrt{3}$	$\sqrt{C_p}$	$\sqrt{C_p}$	1.63299	1.63299
Boundary Effect	1	R	$\sqrt{3}$	1	1	0.57735	0.57735
Linearity	5	R	$\sqrt{3}$	1	1	2.88675	2.88675
System Detection Limits	1	R	$\sqrt{3}$	1	1	0.57735	0.57735
Readout Electronics	0.5	N	1	1	1	0.5	0.5
Response Time	0.2	R	$\sqrt{3}$	1	1	0.11547	0.11547
Integration Time	2	R	$\sqrt{3}$	1	1	1.1547	1.1547
RF Ambient Conditions	3	R	$\sqrt{3}$	1	1	1.73205	1.73205
Probe Positioner Mechanical Tolerances	2	R	$\sqrt{3}$	1	1	1.1547	1.1547
Probe Positioning with respect to Phantom Shell	1	R	$\sqrt{3}$	1	1	0.57735	0.57735
Extrapolation, Interpolation and integration Algorithms for Max. SAR Evaluation.	1.5	R	$\sqrt{3}$	1	1	0.86603	0.86603
Test Sample Related							
Test Sample Positioning	1.5	N	1	1	1	1.5	1.5
Device Holder Uncertainty	5	N	1	1	1	5	5
Output Power Variation – SAR Drift measurement	3	R	$\sqrt{3}$	1	1	1.73205	1.73205
Phantom and Tissue Parameters Related							
Phantom Uncertainty (Shape and thickness Tolerances)	4	R	$\sqrt{3}$	1	1	2.3094	2.394
Liquid Conductivity – deviation from target value	5	R	$\sqrt{3}$	0.64	0.43	1.84752	1.2413
Liquid Conductivity – Measurement Uncertainty	2.5	N	1	0.64	0.43	1.6	1.075
Liquid Permittivity – deviation from target value	3	R	$\sqrt{3}$	0.6	0.49	1.03923	0.8487
Liquid Permittivity – Measurement Uncertainty	2.5	N	1	0.6	0.49	1.5	1.225
Combined Standard Uncertainty						9.66051 %	9.52428 %
Expanded Standard Uncertainty (K=2 , confidence 95%)						18.9346 %	18.6676 %

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8 OUTPUT POWER VERIFICATION

Test Condition:

1. Conducted Measurement
EUT was set for low, mid, high channel with modulated mode and highest RF output power.
The base station simulator was connected to the antenna terminal.
2. Conducted Emissions Measurement Uncertainty
All test measurements carried out are traceable to national standards. The uncertainty of the measurement at a confidence level of approximately 95% (in the case where distributions are normal), with a coverage factor of 2, in the range 30MHz – 40GHz is $\pm 1.5\text{dB}$.
3. Environmental Conditions

Temperature	23°C
Relative Humidity	53%
Atmospheric Pressure	1019mbar
4. Test Date : Sep 14th 2011
Tested By :David Zhang

Test Procedures:**Mobile phone radio output power measurement**

1. The transmitter output port was connected to base station emulator.
2. Establish communication link between emulator and EUT and set EUT to operate at maximum output power all the time.
3. Select lowest, middle, and highest channels for each band and different possible test mode.
4. Measure the conducted peak burst power and conducted average burst power from EUT antenna port.

Other radio output power measurement

The output power was measured using power meter at low, mid, and hi channels.

Test Configuration:

EUT just supports GSM mode. The measurement was made under GSM voice call mode

Test Result:**GSM**

Frequency Band	Channel No.	Frequency	Conducted Average Power(dBm)
GSM850	Low(128)	824.2	32.31
	Mid(190)	836.4	32.53
	High(251)	848.8	32.84
GSM1900	Low(512)	1850.2	28.87
	Mid(661)	1880.0	28.18
	High(810)	1909.8	28.20

Bluetooth Measurement Result

Channel No.	Frequency (MHz)	Conducted Average Burst Power(dBm)	Duty Cycle Factor (dB)	Time Averaged Burst Power(dBm)
0	2402	-0.57	0	-0.57
39	2441	-0.22	0	-0.22
78	2480	0.37	0	0.37



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9 SAR TEST RESULTS

Test Condition:

1. SAR Measurement
The distance between the EUT and the antenna of the emulator is more than 50 cm and the output power radiated from the emulator antenna is at least 30 dB less than the output power of EUT.
2. Measurement Uncertainty: See page 26 for detail
3. Environmental Conditions

Temperature	23°C
Relative Humidity	53%
Atmospheric Pressure	1019mbar
4. Test Date : Sep 14th 2011
Tested By :David Zhang

Test Procedures:

1. Establish communication link between EUT and base station emulation by air link.
3. Place the EUT in the selected test position. (Cheek, tilt or flat)
4. Perform SAR testing at highest output power channel under the selected test mode. If the measured 1-g SAR is ≤ 0.8 W/kg, then testing for the other channel will not be performed.
4. Measure the conducted peak burst power and conducted average burst power from EUT antenna port.

SAR measurement system will proceed the following basic steps:

1. Initial power reference measurement
2. Area Scan
3. Zoom Scan
4. Power drift measurement



Test Result:

Left Head Side

Test Configuration , Left Head , Touch /Tilt			Crest Factor : 8	Date of Measured : Sep 14 th 2011		
Freq Band	Mode	Channel	Position	SAR 10g (W/kg)	SAR 1g (W/kg)	Limit (W/kg)
GSM850	Voice call	High	Cheek	0.479	0.628	1.6
GSM850	Voice call	High	Tilt(15°)	0.342	0.448	1.6
GSM1900	Voice call	Low	Cheek	0.107	0.180	1.6
GSM1900	Voice call	Low	Tilt(15°)	0.057	0.093	1.6

Right Head Side

Test Configuration , Right Head , Touch /Tilt			Crest Factor : 8	Date of Measured : Aug 30 th 2011		
Freq Band	Mode	Channel	Position	SAR 10g (W/kg)	SAR 1g (W/kg)	Limit (W/kg)
GSM850	Voice call	High	Cheek	0.483	0.645	1.6
GSM850	Voice call	High	Tilt(15°)	0.342	0.466	1.6
GSM1900	Voice call	Low	Cheek	0.087	0.152	1.6
GSM1900	Voice call	Low	Tilt(15°)	0.056	0.103	1.6

Body Worn (Separation distance: 1.5cm)

Test Configuration , Body			Crest Factor : 8	Date of Measured : Aug 30 th 2011		
Freq Band	Mode	Channel	Position	SAR 10g (W/kg)	SAR 1g(W/kg)	Limit (W/kg)
GSM850	Voice call	High	LCD up	0.312	0.476	1.6
GSM850	Voice call	High	LCD down	0.425	0.559	1.6
GSM1900	Voice call	Low	LCD up	0.025	0.041	1.6
GSM1900	Voice call	Low	LCD down	0.044	0.072	1.6

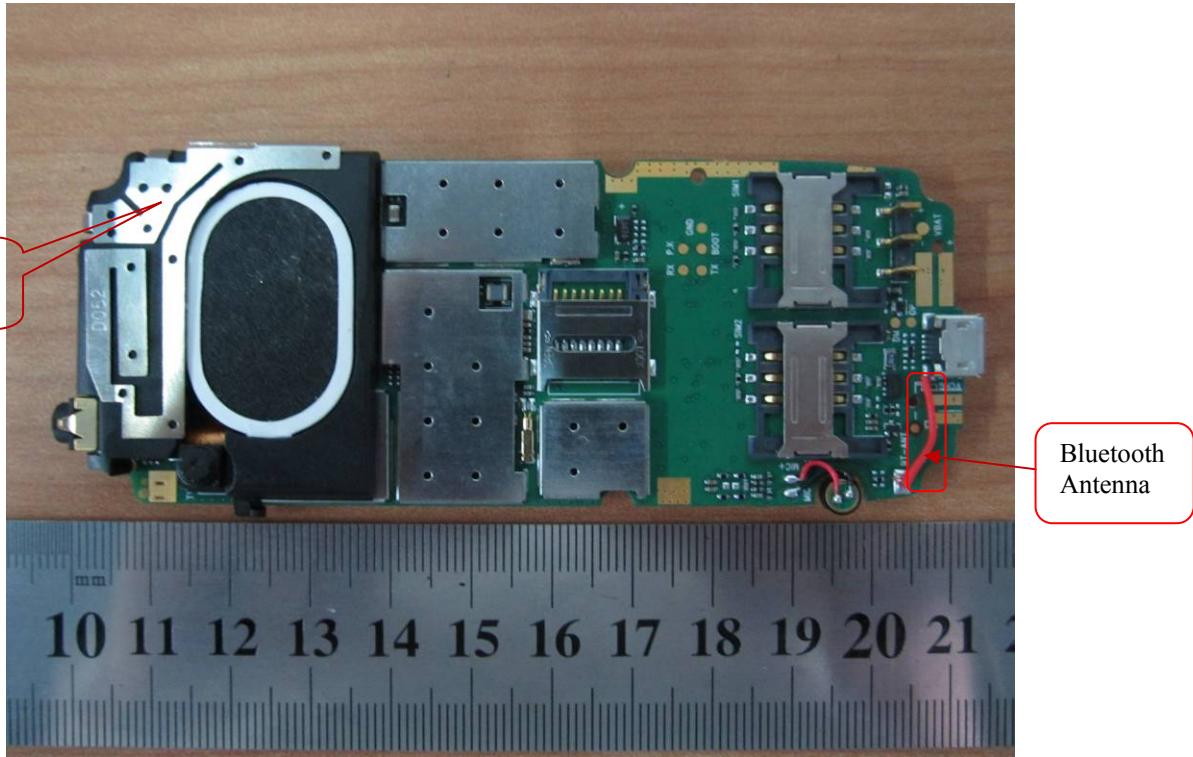
Bluetooth Mode

No stand-alone SAR testing for BT was required because of the low output power.1.089mW< Pref(12 mW)



KDB648474 & Simultaneous SAR Evaluation.

Antenna Separation Information:



PCB Board view

Test Case	TX Ant1	TX Ant2	The shortest distance between Ant & Ant2 (mm)
1	GSM	BT	77mm

Antenna Pair	Justification	Simultaneous SAR required ?
BT / WWAN	BT and GSM Antenna separation is 7.7cm, which is more than 5cm, and the maximum output power is $1.089\text{mW} < 2 \times \text{Pref}(12\text{mW})$	No



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10 SAR MEASUREMENT REFERENCES

References

1. FCC 47 CFR Part 2 “Frequency Allocations and Radio Treaty Matters; General Rules and Regulations”
2. IEEE Std. C95.1-1991, “IEEE Standard for Safety Levels with Respect to Human Exposure to Radio Frequency Electromagnetic Fields, 3kHz to 300GHz”, 1991
3. IEEE Std. 1528-2003, “Recommended Practice for Determining the Peak Spatial-Average Specific Absorption Rate(SAR) in the Human Head from Wireless Communication Devices: Measurement Techniques”, December 2003
4. FCC OET Bulletin 65(Edition 97-01) Supplement C(Edition 01-01), “Evaluation Compliance with FCC Guidelines for Human Exposure to Radiofrequency Electromagnetic Fields”, June 2001
5. FCC KDB 447498 D01 v04, “Mobile and Portable Device RF Exposure Procedures and Equipment Authorization Policies”, November 2009
6. FCC KDB 648474 D01 v01r05, “SAR Evaluation Considerations for Handsets with Multiple Transmitters and Antennas”, September 2008
7. FCC KDB 941225 D04 v01, “Evaluation SAR for GSM/(E)GPRS Dual Transfer Mode”, January 27 2010
8. IEC 62209-2, “Human exposure to radio frequency fields from hand-held and body-mounted wireless communication devices—Human models, instrumentation, and procedures – Part 2: Procedure to determine the specific absorption rate(SAR) for wireless communication devices used in close proximity to the human body(frequency range of 30MHz to 6GHz)”, March 2010

SAR measurement Plots

Test mode: GSM850, high channel (Right Head Cheek)

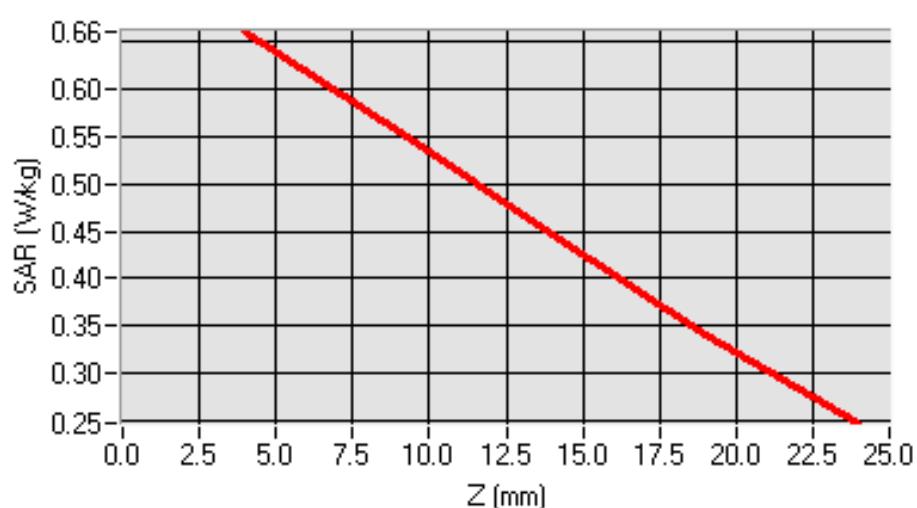
Product Description: Mobile Phone

Model: T8

Test Date: Sep 14th 2011

Frequency (MHz)	848.800000 (Right Head , Cheek)
Relative permittivity (real part)	41.588
Conductivity (S/m)	0.8987
Crest factor	8.0
Conversion Factor	6.04
Variation (%)	1.020000
SAR 10g (W/Kg)	0.483
SAR 1g (W/Kg)	0.645
SURFACE SAR	VOLUME SAR

SAR, Z Axis Scan ($X = -29$, $Y = -9$)



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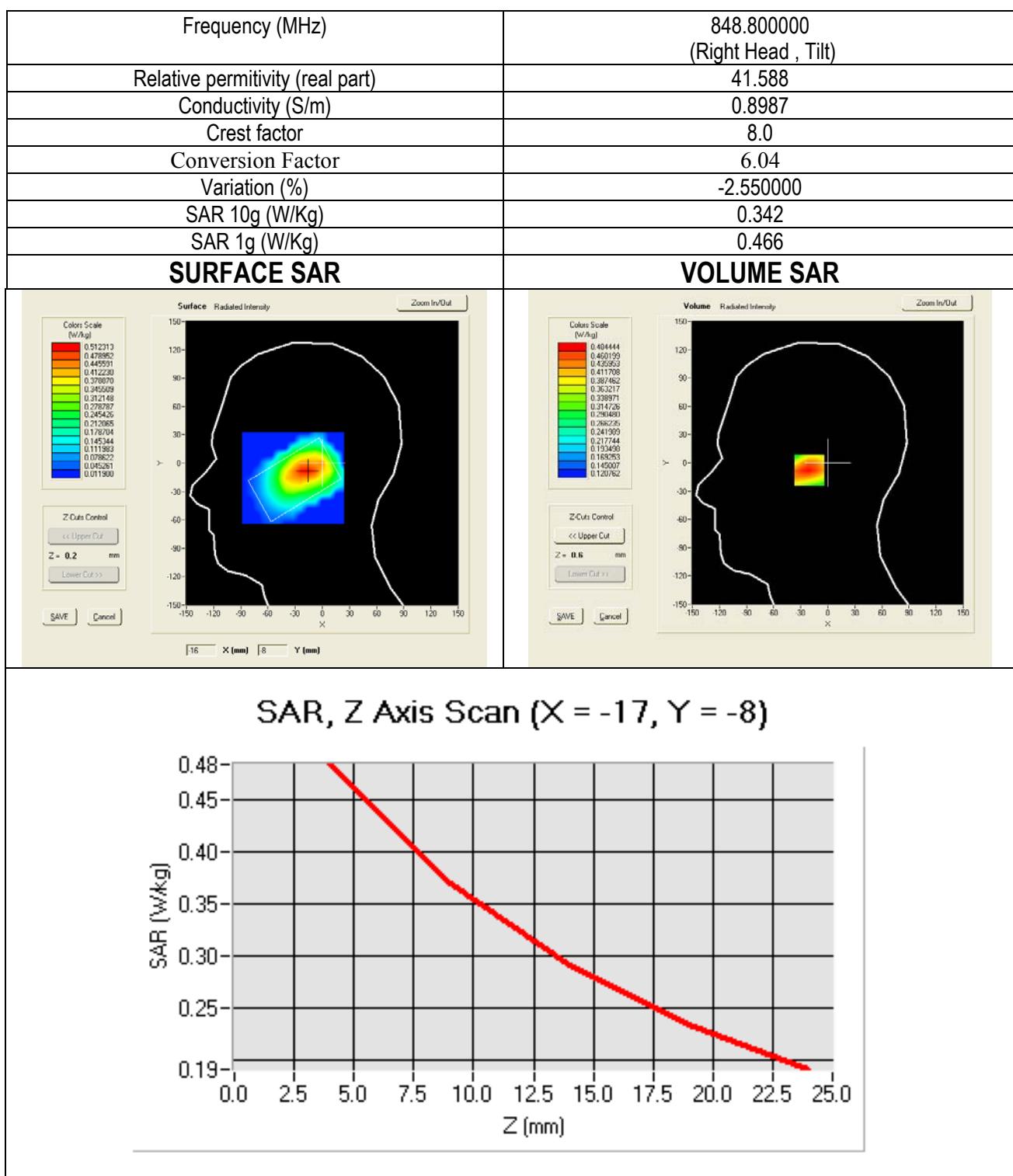
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Test mode: GSM850, high channel (Right Head Tilt)**Product Description: Mobile Phone****Model: T8****Test Date: Sep 14th 2011**



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Test mode: GSM850, high channel (Left Head Cheek)

Product Description: Mobile Phone

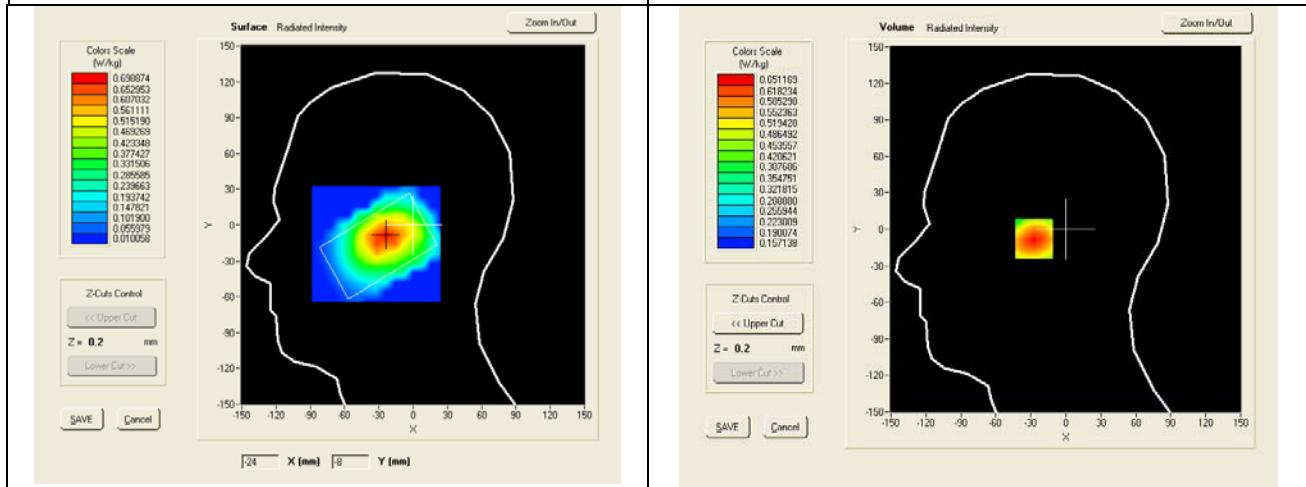
Model: T8

Test Date: Sep 14th 2011

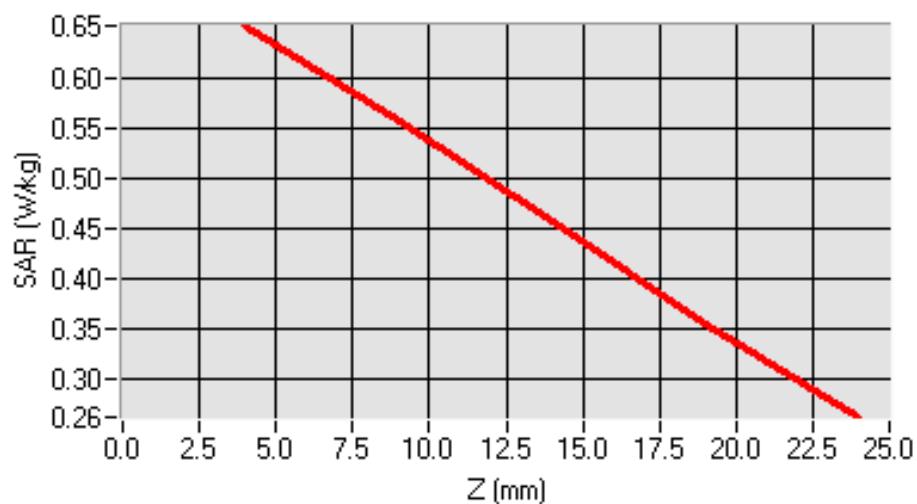
Frequency (MHz)	848.800000 (Left Head , Cheek)
Relative permittivity (real part)	41.588
Conductivity (S/m)	0.8987
Crest factor	8.0
Conversion Factor	6.04
Variation (%)	-1.500000
SAR 10g (W/Kg)	0.479
SAR 1g (W/Kg)	0.628

SURFACE SAR

VOLUME SAR



SAR, Z Axis Scan ($X = -24$, $Y = -8$)



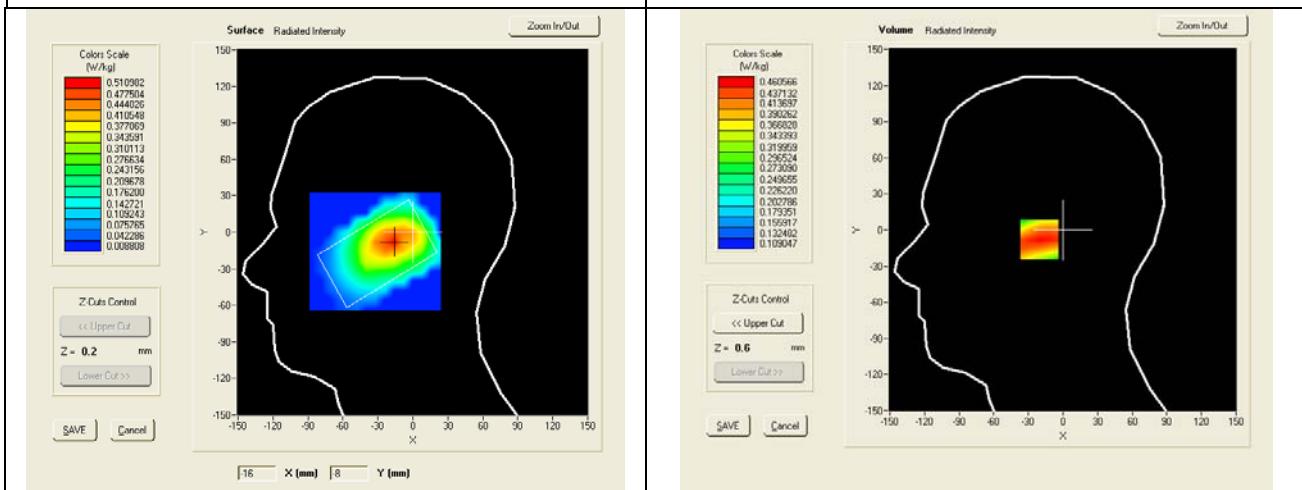
Test mode: GSM850, high channel (Left Head Tilt)

Product Description: Mobile Phone

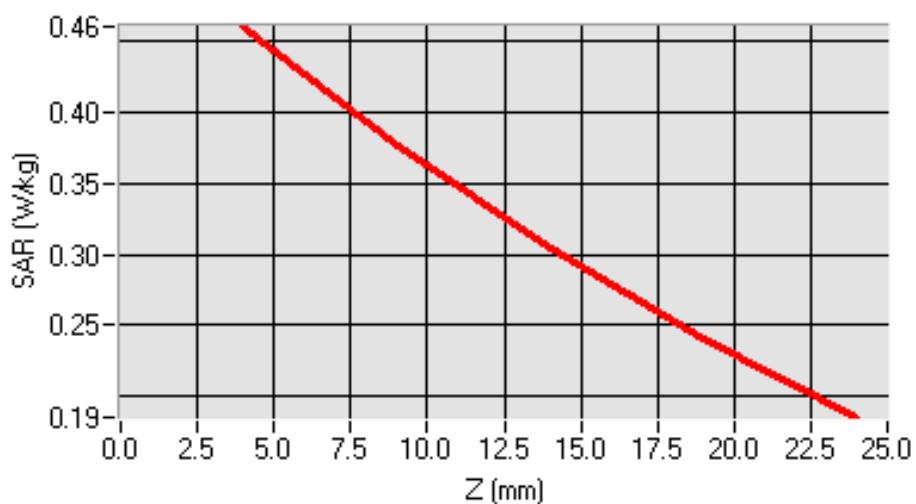
Model: T8

Test Date: Sep 14th 2011

Frequency (MHz)	848.800000
Relative permittivity (real part)	41.588
Conductivity (S/m)	0.8987
Crest factor	8.0
Conversion Factor	6.04
Variation (%)	-4.500000
SAR 10g (W/Kg)	0.342
SAR 1g (W/Kg)	0.448
SURFACE SAR	VOLUME SAR



SAR, Z Axis Scan ($X = -17$, $Y = -8$)



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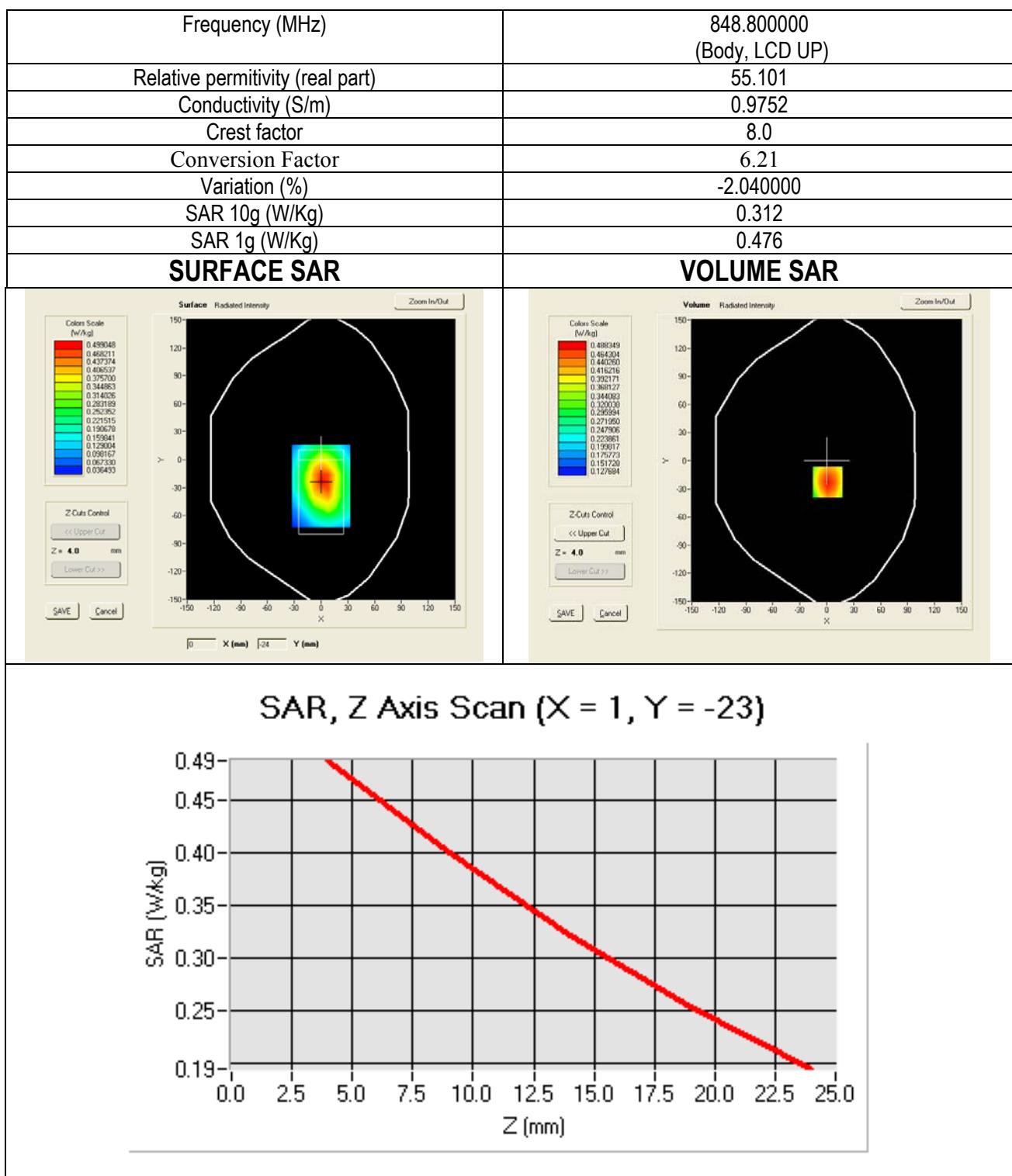
To C95.1, IEEE 1528, OET Bulletin 65 Supplement C, IEC62209-2 & RSS-102
Issue 4 and Safety Code 6

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Test mode: GSM850, high channel (Body-LCD UP)**Product Description: Mobile Phone****Model: T8****Test Date: Sep 14th 2011**

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Model : T8

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Serial# 11070072-SAR

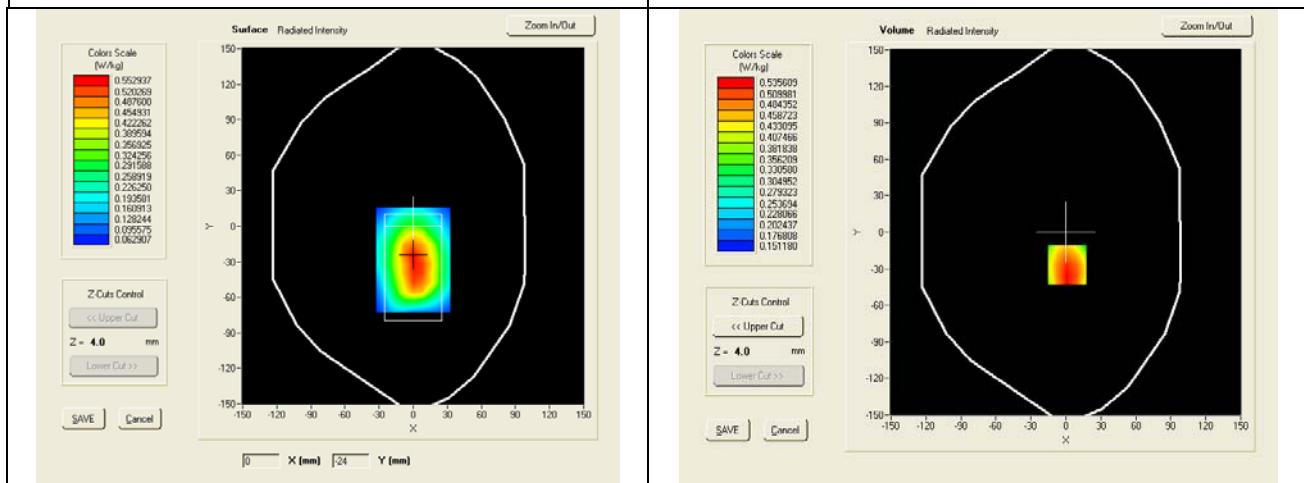
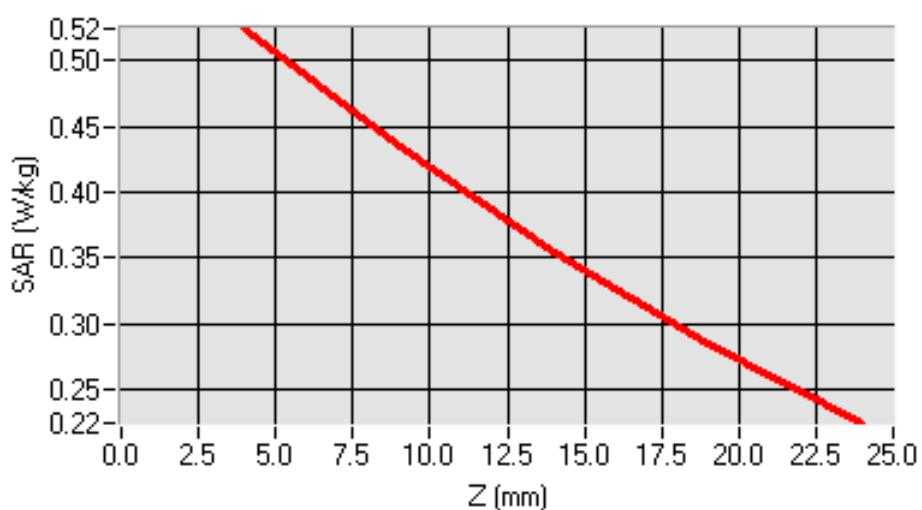
Issue Date Sep 14th 2011

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Test mode: GSM850, high channel (Body-LCD DOWN)**Product Description: Mobile Phone****Model: T8****Test Date: Sep 14th 2011**

Frequency (MHz)	848.800000 (Body, LCD DOWN)
Relative permittivity (real part)	55.101
Conductivity (S/m)	0.9752
Crest factor	8.0
Conversion Factor	6.21
Variation (%)	-2.010000
SAR 10g (W/Kg)	0.425
SAR 1g (W/Kg)	0.559

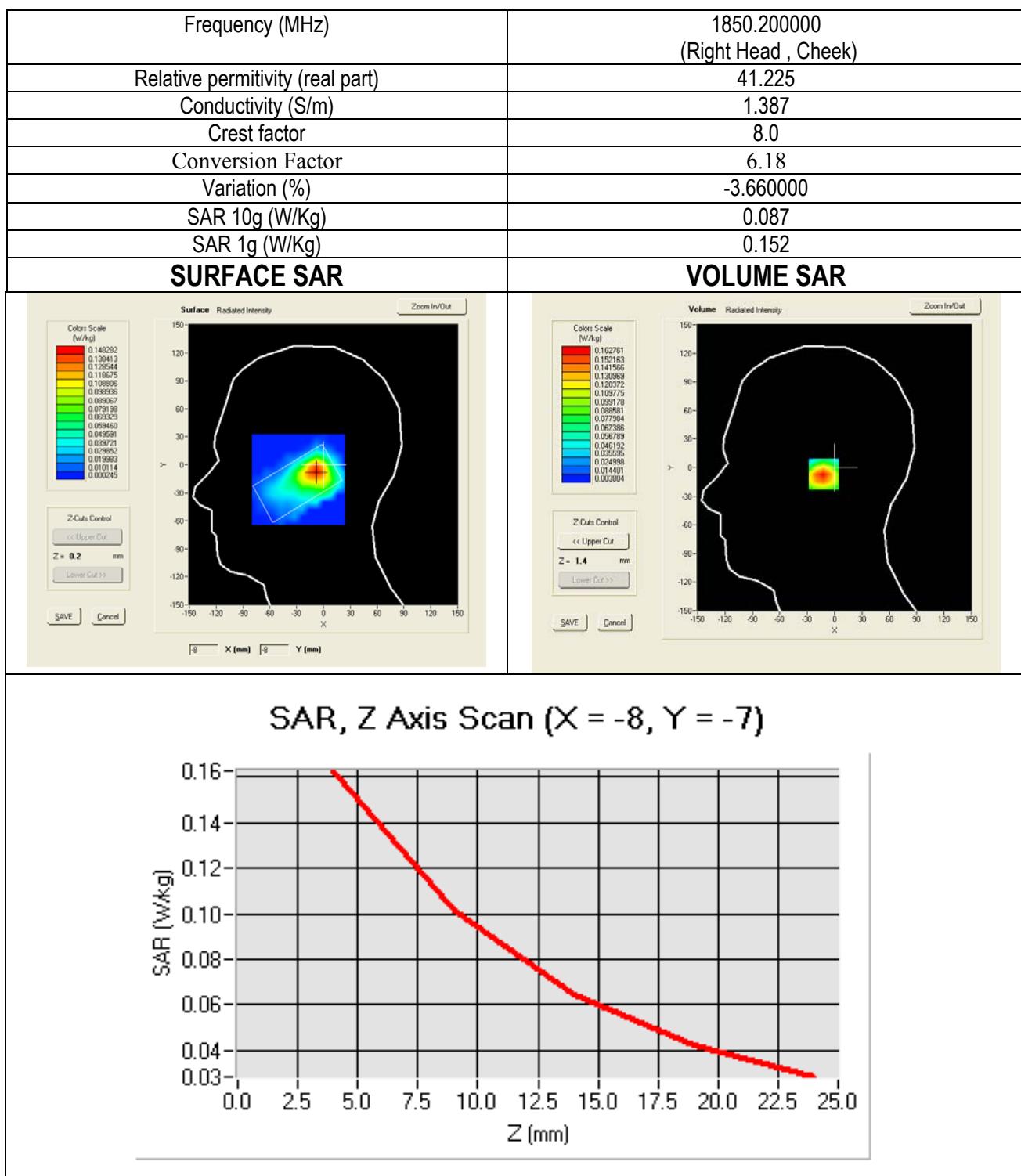
SURFACE SAR**VOLUME SAR****SAR, Z Axis Scan ($X = 1$, $Y = -27$)**

Test mode: GSM1900, low channel (Right Head Cheek)

Product Description: Mobile Phone

Model: T8

Test Date: Sep 14th 2011



Test mode: GSM1900, low channel (Right Head Tilt)

Product Description: Mobile Phone

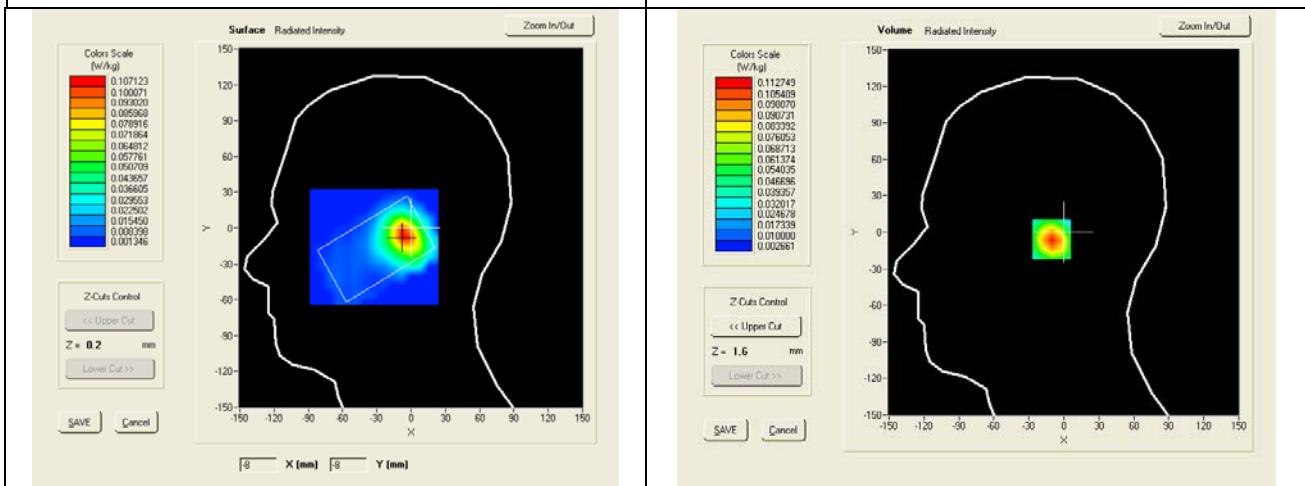
Model: T8

Test Date: Sep 14th 2011

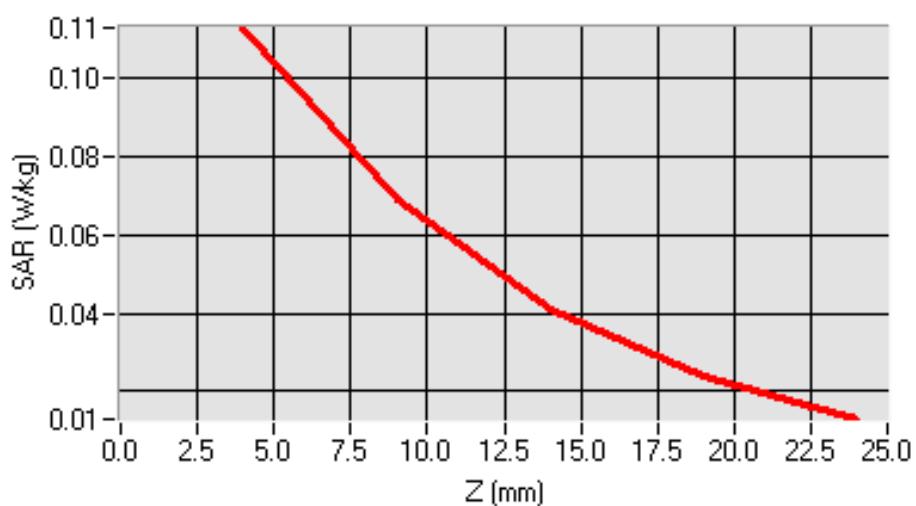
Frequency (MHz)	1850.200000 (Right Head , Tilt)
Relative permittivity (real part)	41.225
Conductivity (S/m)	1.387
Crest factor	8.0
Conversion Factor	6.18
Variation (%)	1.780000
SAR 10g (W/Kg)	0.056
SAR 1g (W/Kg)	0.103

SURFACE SAR

VOLUME SAR



SAR, Z Axis Scan (X = -6, Y = -6)



Test mode: GSM1900, low channel (Left Head Cheek)

Product Description: Mobile Phone

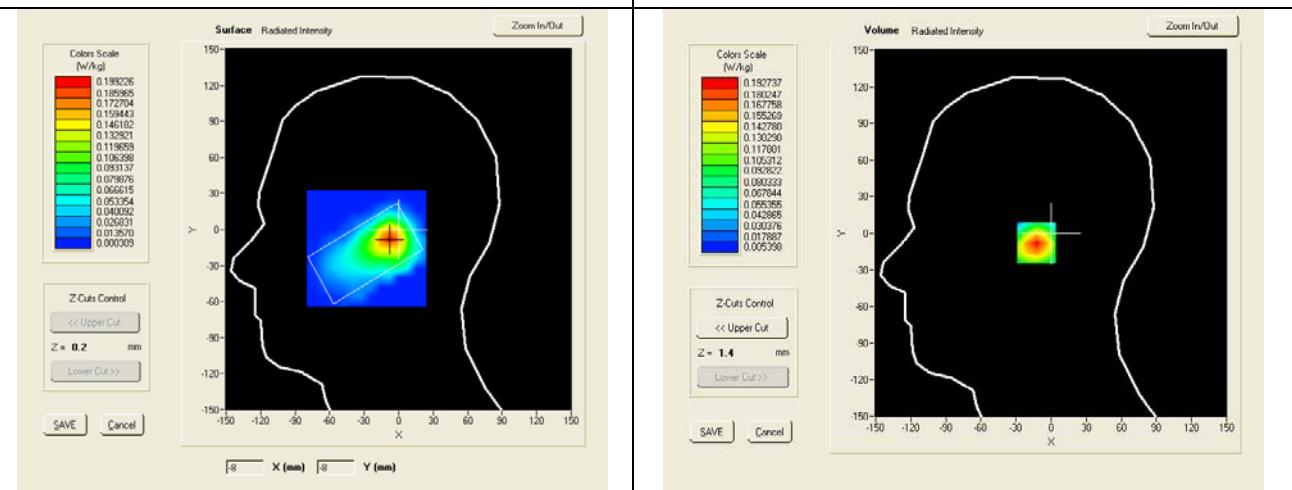
Model: T8

Test Date: Sep 14th 2011

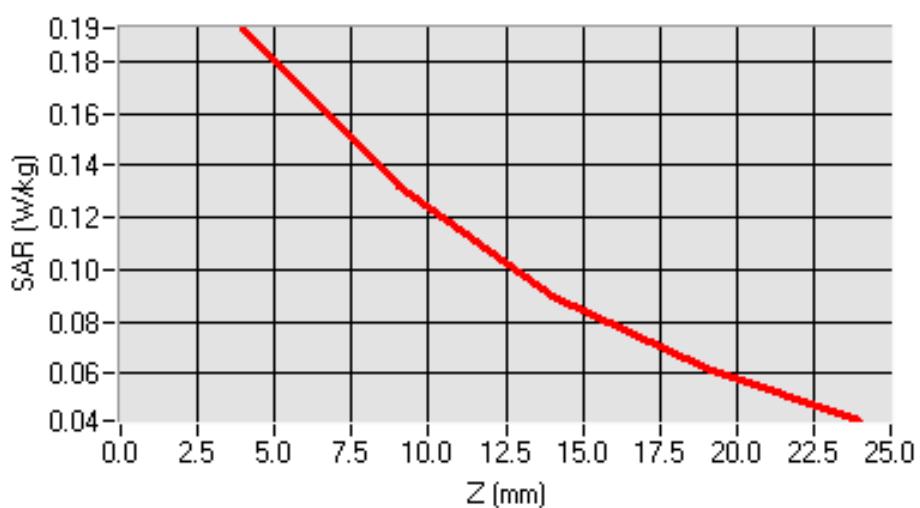
Frequency (MHz)	1850.200000 (Left Head , Cheek)
Relative permittivity (real part)	41.225
Conductivity (S/m)	1.387
Crest factor	8.0
Conversion Factor	6.18
Variation (%)	-2.770000
SAR 10g (W/Kg)	0.107
SAR 1g (W/Kg)	0.180

SURFACE SAR

VOLUME SAR



SAR, Z Axis Scan ($X = -8$, $Y = -8$)



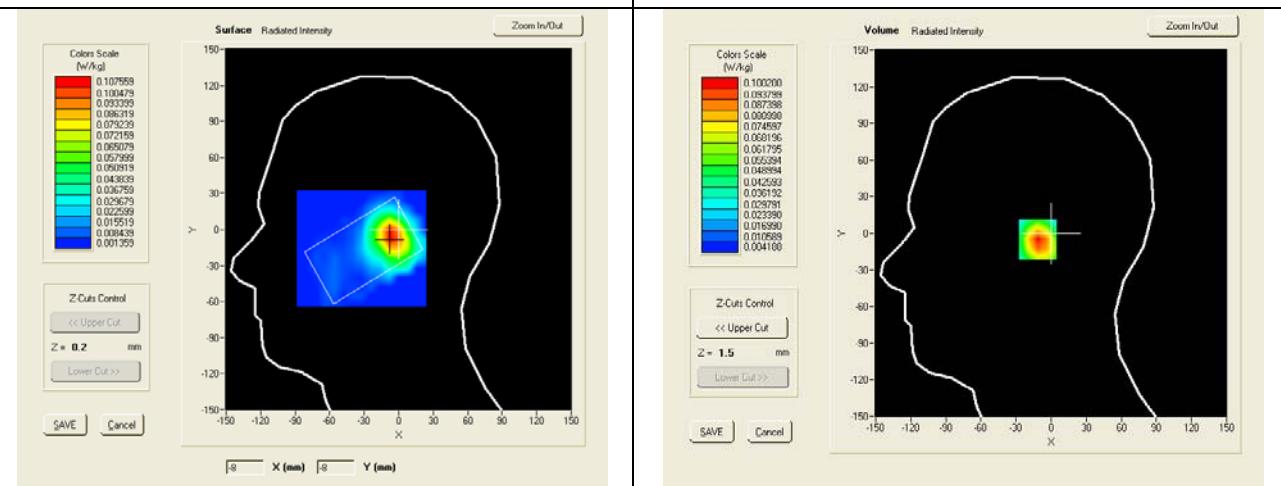
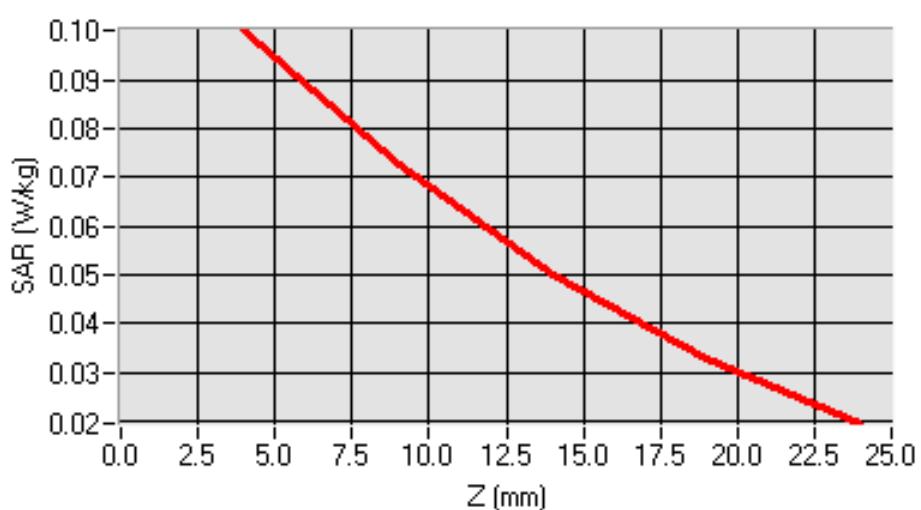
Test mode: GSM1900, low channel (Left Head Tilt)

Product Description: Mobile Phone

Model: T8

Test Date: Sep 14th 2011

Frequency (MHz)	1850.200000 (Left Head , Tilt)
Relative permittivity (real part)	41.225
Conductivity (S/m)	1.387
Crest factor	8.0
Conversion Factor	6.18
Variation (%)	1.760000
SAR 10g (W/Kg)	0.057
SAR 1g (W/Kg)	0.093

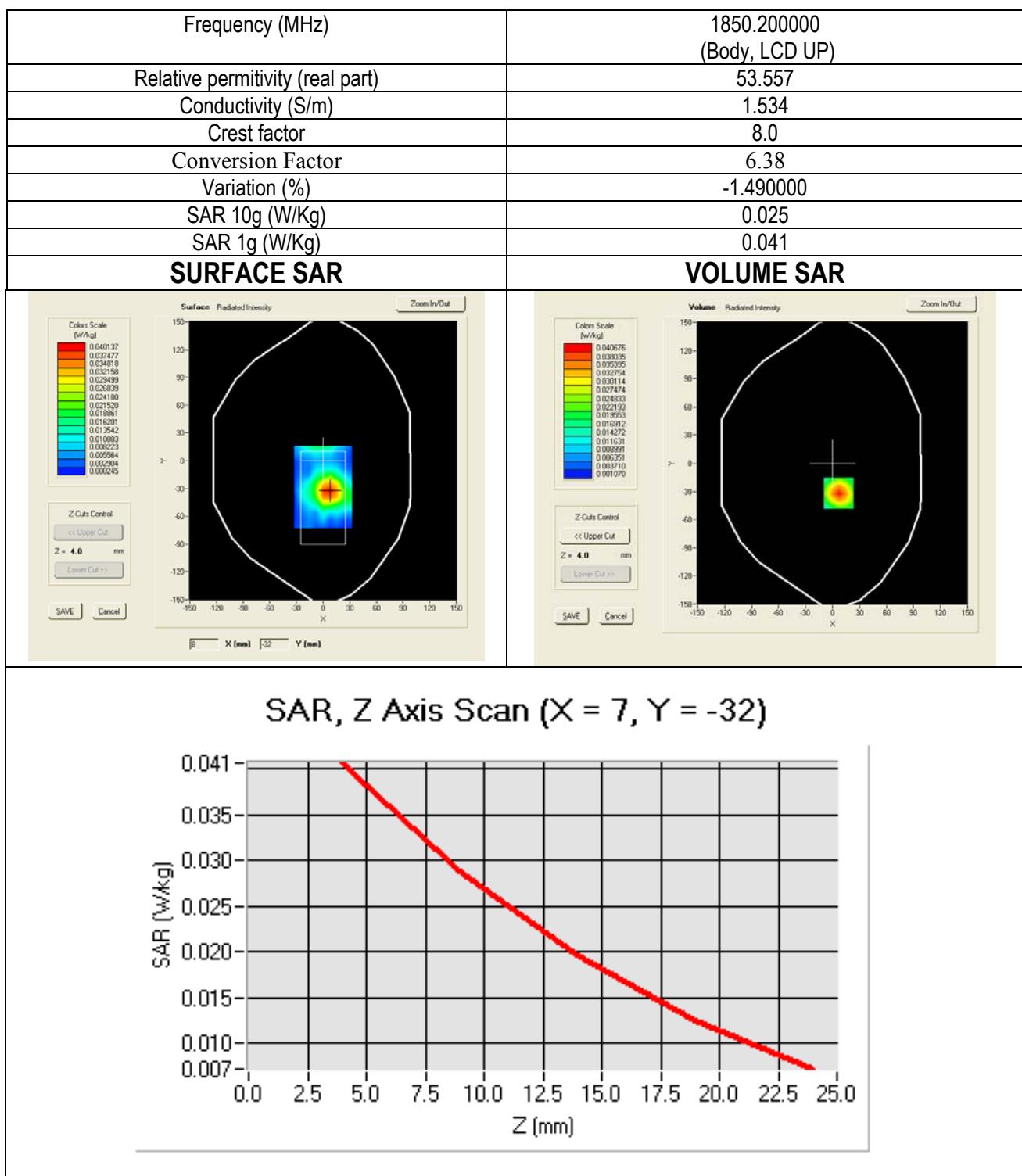
SURFACE SAR**VOLUME SAR****SAR, Z Axis Scan (X = -7, Y = -5)**

Test mode: GSM1900, low channel (Body LCD-UP)

Product Description: Mobile Phone

Model: T8

Test Date: Sep 14th 2011



Test mode: GSM1900, low channel (Body LCD-DOWN)

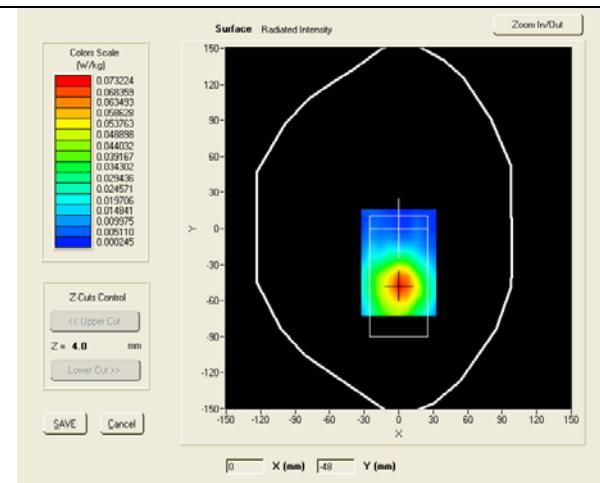
Product Description: Mobile Phone

Model: T8

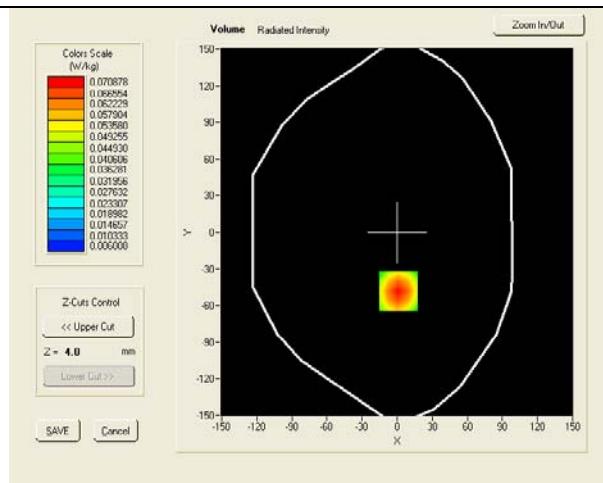
Test Date: Sep 14th 2011

Frequency (MHz)	1850.200000 (Body, LCD DOWN)
Relative permittivity (real part)	53.557
Conductivity (S/m)	1.534
Crest factor	8.0
Conversion Factor	6.38
Variation (%)	0.610000
SAR 10g (W/Kg)	0.044
SAR 1g (W/Kg)	0.072

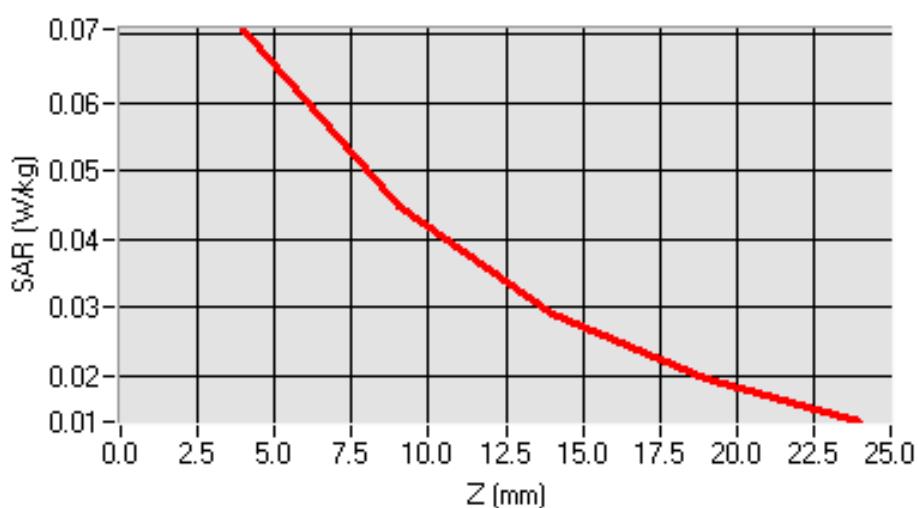
SURFACE SAR



VOLUME SAR



SAR, Z Axis Scan (X = 1, Y = -48)





Annex A. TEST INSTRUMENT & METHOD

Annex A.i. TEST INSTRUMENTATION & GENERAL PROCEDURES

Name of Equipment	Manufacturer	Type/Model	Serial Number	Calibration Due
P C	Compaq	PV 3.06GHz	375052-AA1	N/A
Signal Generator	Agilent	8665B-008	3744A10293	05/17/2012
MultiMeter	Keithley	MiltiMeter 2000	1259033	06/21/2012
S-Parameter Network Analyzer	Agilent	8753ES	US39173518	08/04/2012
Wireless Communication Test Set	R & S	CMU200	111078	07/22/2012
Power Meter	HP	437B	3038A03648	05/17/2012
E-field PROBE	SATIMO	SSE2	SN 18/11 EPG122	07/19/2012
DIPOLE 835	SATIMO	DIPOLE 835MHz	SN 18/11 DIPC 150	06/01/2012
DIPOLE 900	SATIMO	DIPOLE 900MHz	SN 18/11 DIPC 151	06/01/2012
DIPOLE 1800	SATIMO	DIPOLE 1800MHz	SN 18/11 DIPC 152	06/01/2012
DIPOLE 1900	SATIMO	DIPOLE 1900MHz	SN 18/11 DIPG 153	06/01/2012
DIPOLE 2000	SATIMO	DIPOLE 2000MHz	SN 18/11 DIPC 154	06/01/2012
DIPOLE 2450	SATIMO	DIPOLE 2450MHz	SN 18/11 DIPJ 155	06/01/2012
DIPOLE 3500	SATIMO	DIPOLE 3500MHz	SN 18/11 DIPC 156	06/01/2012
WaveGuide 5/6 GHz	SATIMO	Wave Guide 5/6GHz	SN 31/10 DIPWGA13	06/01/2012
COMOHAC E-Field Probe	SATIMO	EPH30	SN 24/11 EPH30	06/01/2012
COMOHAC H-Field Probe	SATIMO	HPH42	SN 43/10 HPH42	06/01/2012
COMOSAR Open Coaxial Probe	SATIMO	OCP43	SN 24/11 OCPG43	06/01/2012
T-Coil Probe	SATIMO	TCP21	SN 24/11 TCP21	06/01/2012
Communication Antenna	SATIMO	ANTA3	SN 20/11 ANTA 3	06/20/2012
Laptop POSITIONING DEVICE	SATIMO	LSH15	SN 24/11 LSH15	N/A
Mobile Phone POSITIONING DEVICE	SATIMO	MSH73	SN 24/11 MSH73	N/A
COMOHAC Broadband Dipole 800-950	SATIMO	COMOHAC Broadband Dipole 800-950MHz	SN 24/11 DHA31	06/01/2012
COMOHAC Broadband Dipole 1700-2000	SATIMO	COMOHAC Broadband Dipole 1700-2000MHz	SN 24/11 DHB32	06/01/2012
COMOHAC TELEPHONE MAGNETIC FIELD SIMULATOR	SATIMO	TMFS12	SN 24/11 TMFS12	06/01/2012
DUMMY PROBE	ANTENNESSA	DP41	SN 24/11DP41	N/A



SAM PHANTOM	SATIMO	SAM87	SN 24/11 SAM87	N/A
Elliptic Phantom	SATIMO	ELLI20	SN 20/11ELLI20	N/A
PHANTOM TABLE	SATIMO	N/A	N/A	N/A
6 AXIS ROBOT	KUKA	KR5	949272	N/A
High Power Solid State Amplifier (80MHz~1000MHz)	Instruments for Industry	CMC150	M631-0408	N/A
Medium Power Solid State Amplifier (0.8~4.2GHz)	Instruments for Industry	S41-25	M629-0408	N/A
Wave Tube Amplifier 4-8 GHz at 20Watt	Hughes Aircraft Company	1277H02F000	81	N/A



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Model : T8

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Annex B CALIBRATION REPORTS



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COMOSAR E-Field Probe Calibration Report

Ref : ACR.200.1.11.SATU.A

SIEMIC TESTING AND CERTIFICATION SERVICES

SUITE 311, BUILDING 1, SECTION 30 ,NO.2 KEFA ROAD,
SCIENCE AND TECHNOLOGY PARK
NAN SHAN DISTRICT, SHENZHEN 518057 , GUANGDONG
,P.R.C.

SATIMO COMOSAR DOSIMETRIC E-FIELD PROBE
SERIAL NO.: SN 18/11 EPG122

Calibrated at SATIMO US

2105 Barrett Park Dr. - Kennesaw, GA 30144



06/01/2011

Summary:

This document presents the method and results from an accredited COMOSAR Dosimetric E-Field Probe calibration performed in SATIMO USA using the CALISAR / CALIBAIR test bench, for use with a SATIMO COMOSAR system only. All calibration results are traceable to national metrology institutions.



COMOSAR E-FIELD PROBE CALIBRATION REPORT

Ref: ACR.200.1.11.SATU.A

	Name	Function	Date	Signature
Prepared by :	Jérôme LUC	Product Manager	7/19/2011	
Checked by :	Jérôme LUC	Product Manager	7/19/2011	
Approved by :	Kim RUTKOWSKI	Quality Manager	7/19/2011	

Distribution :	Customer Name
	SIEMIC Testing and Certification Services

Issue	Date	Modifications
A	7/19/2011	Initial release



COMOSAR E-FIELD PROBE CALIBRATION REPORT

Ref: ACR.200.1.11.SATU.A

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COMOSAR E-FIELD PROBE CALIBRATION REPORT

Ref: ACR.200.1.11.SATU.A

1 DEVICE UNDER TEST

Device Under Test	
Device Type	COMOSAR DOSIMETRIC E FIELD PROBE
Manufacturer	Satimo
Model	SSE2
Serial Number	SN 18/11 EPG122
Product Condition (new / used)	new
Frequency Range of Probe	0.7 GHz-6GHz
Resistance of Three Dipoles at Connector	Dipole 1: R1=0.189 MΩ Dipole 2: R2=0.191 MΩ Dipole 3: R3=0.184 MΩ

A yearly calibration interval is recommended.

2 PRODUCT DESCRIPTION

2.1 GENERAL INFORMATION

Satimo's COMOSAR E field Probes are built in accordance to the IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards.



Figure 1 – Satimo COMOSAR Dosimetric Efield Dipole

Probe Length	330 mm
Length of Individual Dipoles	2 mm
Maximum external diameter	8 mm
Probe Tip External Diameter	2.5 mm
Distance between dipoles / probe extremity	1 mm

3 MEASUREMENT METHOD

The IEEE 1528, OET 65 Bulletin C, CENELEC EN50361 and CEI/IEC 62209 standards provide recommended practices for the probe calibrations, including the performance characteristics of interest and methods by which to assess their affect. All calibrations / measurements performed meet the fore mentioned standards.

3.1 LINEARITY

The evaluation of the linearity was done in free space using the waveguide, performing a power sweep to cover the SAR range 0.01W/kg to 100W/kg.



COMOSAR E-FIELD PROBE CALIBRATION REPORT

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3.2 SENSITIVITY

The sensitivity factors of the three dipoles were determined using a two step calibration method (air and tissue simulating liquid) using waveguides as outlined in the standards.

3.3 LOWER DETECTION LIMIT

The lower detection limit was assessed using the same measurement set up as used for the linearity measurement. The required lower detection limit is 10 mW/kg.

3.4 ISOTROPY

The axial isotropy was evaluated by exposing the probe to a reference wave from a standard dipole with the dipole mounted under the flat phantom in the test configuration suggested for system validations and checks. The probe was rotated along its main axis from 0 - 360 degrees in 15 degree steps. The hemispherical isotropy is determined by inserting the probe in a thin plastic box filled with tissue-equivalent liquid, with the plastic box illuminated with the fields from a half wave dipole. The dipole is rotated about its axis (0°–180°) in 15° increments. At each step the probe is rotated about its axis (0°–360°).

3.5 BOUNDARY EFFECT

The boundary effect is defined as the deviation between the SAR measured data and the expected exponential decay in the liquid when the probe is oriented normal to the interface. To evaluate this effect, the liquid filled flat phantom is exposed to fields from either a reference dipole or waveguide. With the probe normal to the phantom surface, the peak spatial average SAR is measured and compared to the analytical value at the surface.

4 MEASUREMENT UNCERTAINTY

The guidelines outlined in the IEEE 1528, OET 65 Bulletin C, CENELEC EN50361 and CEI/IEC 62209 standards were followed to generate the measurement uncertainty associated with an E-field probe calibration using the waveguide technique. All uncertainties listed below represent an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2, traceable to the Internationally Accepted Guides to Measurement Uncertainty.

Uncertainty analysis of the probe calibration in waveguide					
ERROR SOURCES	Uncertainty value (%)	Probability Distribution	Divisor	ci	Standard Uncertainty (%)
Incident or forward power	3.00%	Rectangular	$\sqrt{3}$	1	1.732%
Reflected power	3.00%	Rectangular	$\sqrt{3}$	1	1.732%
Liquid conductivity	5.00%	Rectangular	$\sqrt{3}$	1	2.887%
Liquid permittivity	4.00%	Rectangular	$\sqrt{3}$	1	2.309%
Field homogeneity	3.00%	Rectangular	$\sqrt{3}$	1	1.732%
Field probe positioning	5.00%	Rectangular	$\sqrt{3}$	1	2.887%
Field probe linearity	3.00%	Rectangular	$\sqrt{3}$	1	1.732%



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Combined standard uncertainty					5.831%
Expanded uncertainty 95 % confidence level k = 2					11.662%

5 CALIBRATION MEASUREMENT RESULTS

Calibration Parameters	
Liquid Temperature	21 °C
Lab Temperature	21 °C
Lab Humidity	45 %

5.1 SENSITIVITY IN AIR

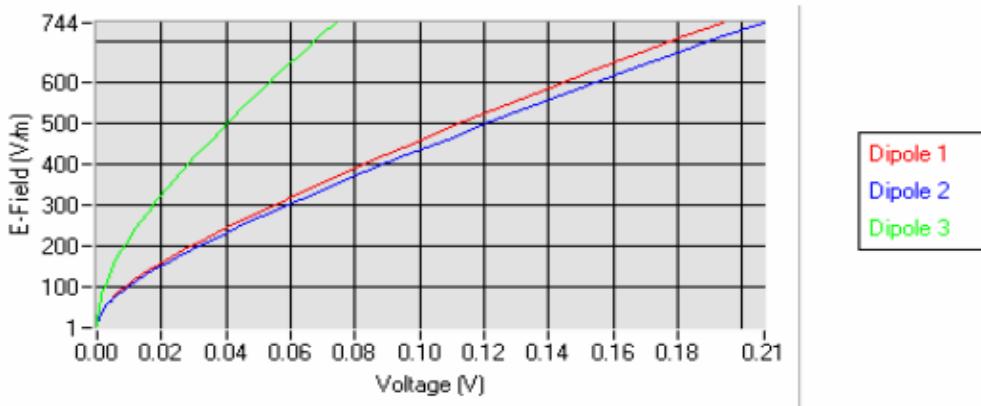
Normx dipole 1 ($\mu\text{V}/(\text{V}/\text{m})^2$)	Normy dipole 2 ($\mu\text{V}/(\text{V}/\text{m})^2$)	Normz dipole 3 ($\mu\text{V}/(\text{V}/\text{m})^2$)
0.89	0.98	0.22

DCP dipole 1 (mV)	DCP dipole 2 (mV)	DCP dipole 3 (mV)
115	117	122

Calibration curves $e_i=f(V)$ ($i=1,2,3$) allow to obtain H-field value using the formula:

$$E = \sqrt{E_1^2 + E_2^2 + E_3^2}$$

Calibration curves

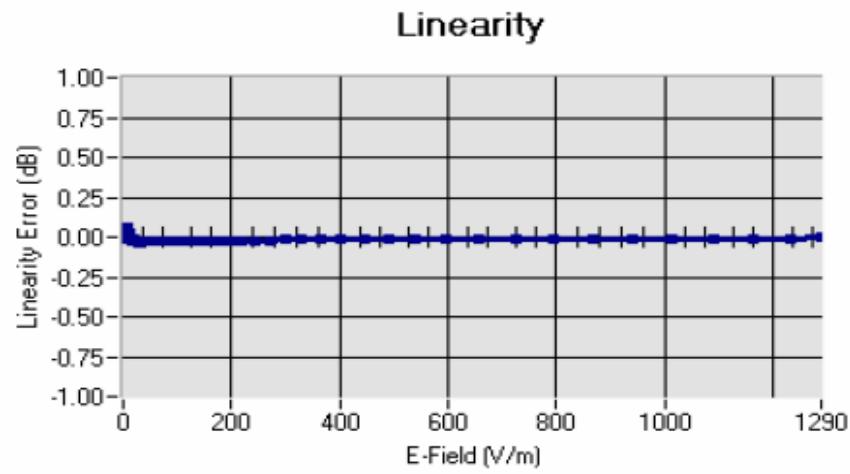




COMOSAR E-FIELD PROBE CALIBRATION REPORT

Ref: ACR.200.1.11.SATU.A

5.2 LINEARITY



Linearity: +/- 1.47% (+/- 0.06dB)

5.3 SENSITIVITY IN LIQUID

Liquid	Frequency (MHz +/- 100MHz)	Permittivity	Epsilon (S/m)	ConvF
HL850	835	43.04	0.88	6.04
BL850	835	54.21	0.98	6.21
HL900	900	41.99	0.96	5.84
BL900	900	53.68	1.04	6.06
HL1800	1750	38.73	1.37	5.78
BL1800	1750	53.55	1.51	5.99
HL1900	1880	38.51	1.42	6.18
BL1900	1880	54.65	1.54	6.38
HL2000	1950	38.55	1.46	5.75
BL2000	1950	53.54	1.49	5.87
HL2450	2450	38.77	1.88	5.81
BL2450	2450	52.36	1.97	5.98
HL3500	3500	38.69	2.87	6.03
BL3500	3500	51.87	3.21	6.27
HL5200	5200	36.80	4.87	4.93
BL5200	5200	49.25	5.06	5.09
HL5500	5500	35.83	5.35	4.69
BL5500	5500	48.28	5.58	4.91
HL5800	5800	34.75	5.77	4.71
BL5800	5800	47.51	6.07	4.84

LOWER DETECTION LIMIT: 7mW/kg

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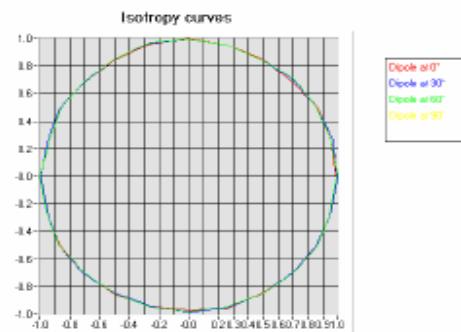
COMOSAR E-FIELD PROBE CALIBRATION REPORT

Ref: ACR.200.1.11.SATU..

5.4 ISOTROPY

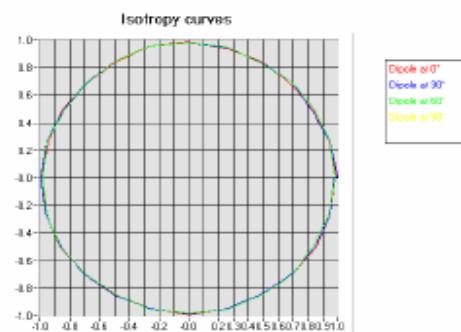
HL900 MHz

- Axial isotropy: 0.05 dB
- Hemispherical isotropy: 0.07 dB



HL1800 MHz

- Axial isotropy: 0.05 dB
- Hemispherical isotropy: 0.08 dB





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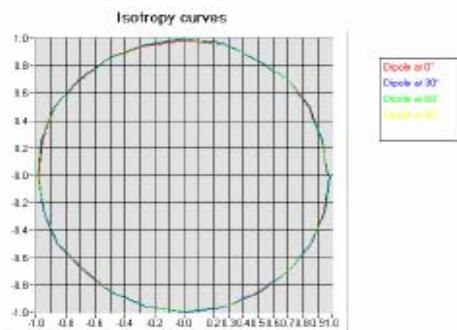


COMOSAR E-FIELD PROBE CALIBRATION REPORT

Ref: ACR.200.1.11.SATU.A

HL5500 MHz

- Axial isotropy: 0.09 dB
- Hemispherical isotropy: 0.13 dB



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**COMOSAR E-FIELD PROBE CALIBRATION REPORT**

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6 LIST OF EQUIPMENT**Equipment Summary Sheet**

Equipment Description	Manufacturer / Model	Identification No.	Current Calibration Date	Next Calibration Date
Flat Phantom	Satimo	SN-20/09-SAM71	Validated. No cal required.	Validated. No cal required.
COMOSAR Test Bench	Version 3	NA	Validated. No cal required.	Validated. No cal required.
Network Analyzer	Rhode & Schwarz ZVA	SN100132	02/2010	02/2013
Reference Probe	Satimo	EP 94 SN 37/08	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Multimeter	Keithley 2000	1188656	11/2010	11/2013
Signal Generator	Agilent E4438C	MY49070581	12/2010	12/2013
Amplifier	Aethercomm	SN 046	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Power Meter	HP E4418A	US38261498	11/2010	11/2013
Power Sensor	HP ECP-E26A	US37181460	11/2010	11/2013
Directional Coupler	Narda 4216-20	01386	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Waveguide	Mega Industries	069Y7-158-13-712	Validated. No cal required.	Validated. No cal required.
Waveguide Transition	Mega Industries	069Y7-158-13-701	Validated. No cal required.	Validated. No cal required.
Waveguide Termination	Mega Industries	069Y7-158-13-701	Validated. No cal required.	Validated. No cal required.
Temperature / Humidity Sensor	Control Company	11-661-9	3/2010	3/2012

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Model : T8

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SAR Reference Dipole Calibration Report

Ref : ACR.158.4.11.SATU.A

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SCIENCE AND TECHNOLOGY PARK
NAN SHAN DISTRICT, SHENZHEN 518057 , GUANGDONG
P.R.C.**

SATIMO COMOSAR REFERENCE DIPOLE

Calibrated at SATIMO US

2105 Barrett Park Dr. - Kennesaw, GA 30144



06/01/2011

Summary:

This document presents the method and results from an accredited SAR reference dipole calibration performed in SATIMO USA using the COMOSAR test bench. All calibration results are traceable to national metrology institutions.



SAR REFERENCE DIPOLE CALIBRATION REPORT

Ref: ACR.158.4.11.SATU.A

	Name	Function	Date	Signature
Prepared by :	Jérôme LUC	Product Manager	6/7/2011	
Checked by :	Jérôme LUC	Product Manager	6/7/2011	
Approved by :	Kim RUTKOWSKI	Quality Manager	6/7/2011	

Distribution :	Customer Name
	SIEMIC Testing and Certification Services

Issue	Date	Modifications
A	6/7/2011	Initial release



SAR REFERENCE DIPOLE CALIBRATION REPORT

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6	Calibration Measurement Results.....	6
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**SAR REFERENCE DIPOLE CALIBRATION REPORT**

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1 INTRODUCTION

This document contains a summary of the requirements set forth by the IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards for reference dipoles used for SAR measurement system validations and the measurements that were performed to verify that the product complies with the fore mentioned standards.

2 DEVICE UNDER TEST

Device Under Test	
Device Type	COMOSAR 835 MHz REFERENCE DIPOLE
Manufacturer	Satimo
Model	SID835
Serial Number	SN 18/11 DIPC150
Product Condition (new / used)	new

A yearly calibration interval is recommended.

3 PRODUCT DESCRIPTION**3.1 GENERAL INFORMATION**

Satimo's COMOSAR Validation Dipoles are built in accordance to the IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards. The product is designed for use with the COMOSAR test bench only.



Figure 1 – Satimo COMOSAR Validation Dipole

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4 MEASUREMENT METHOD

The IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards provide requirements for reference dipoles used for system validation measurements. The following measurements were performed to verify that the product complies with the fore mentioned standards.

4.1 RETURN LOSS REQUIREMENTS

The dipole used for SAR system validation measurements and checks must have a return loss of -20 dB or better. The return loss measurement shall be performed against a liquid filled flat phantom, with the phantom constructed as outlined in the fore mentioned standards.

4.2 MECHANICAL REQUIREMENTS

The IEEE Std. 1528 and CEI/IEC 62209 standards specify the mechanical components and dimensions of the validation dipoles, with the dimensions frequency and phantom shell thickness dependent. The COMOSAR test bench employs a 2 mm phantom shell thickness therefore the dipoles sold for use with the COMOSAR test bench comply with the requirements set forth for a 2 mm phantom shell thickness.

5 MEASUREMENT UNCERTAINTY

All uncertainties listed below represent an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2, traceable to the Internationally Accepted Guides to Measurement Uncertainty.

5.1 RETURN LOSS

The following uncertainties apply to the return loss measurement:

Frequency band	Expanded Uncertainty on Return Loss
400-6000MHz	0.1 dB

5.2 DIMENSION MEASUREMENT

The following uncertainties apply to the dimension measurements:

Length (mm)	Expanded Uncertainty on Length
3 - 300	0.05 mm

5.3 VALIDATION MEASUREMENT

The guidelines outlined in the IEEE 1528, OET 65 Bulletin C, CENELEC EN50361 and CEI/IEC 62209 standards were followed to generate the measurement uncertainty for validation measurements.

Scan Volume	Expanded Uncertainty
1 g	16.19 %
10 g	15.86 %

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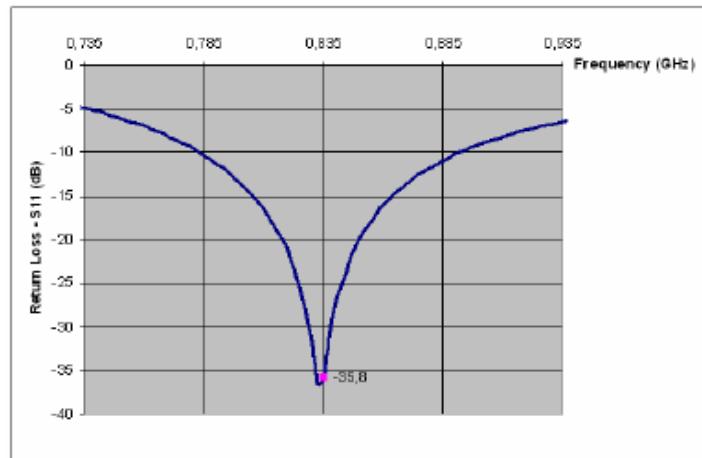
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6 CALIBRATION MEASUREMENT RESULTS**6.1 RETURN LOSS**

Frequency (MHz)	Return Loss (dB)	Requirement (dB)
835	-35.8	-20

6.2 MECHANICAL DIMENSIONS

Frequency MHz	L mm		h mm		d mm	
	required	measured	required	measured	required	measured
300	420.0 ±1 %.		250.0 ±1 %.		6.35 ±1 %.	
450	290.0 ±1 %.		166.7 ±1 %.		6.35 ±1 %.	
750	176.0 ±1 %.		100.0 ±1 %.		6.35 ±1 %.	
835	161.0 ±1 %.	PASS	89.8 ±1 %.	PASS	3.6 ±1 %.	PASS
900	149.0 ±1 %.		83.3 ±1 %.		3.6 ±1 %.	
1450	89.1 ±1 %.		51.7 ±1 %.		3.6 ±1 %.	
1500	80.5 ±1 %.		50.0 ±1 %.		3.6 ±1 %.	
1640	79.0 ±1 %.		45.7 ±1 %.		3.6 ±1 %.	
1750	75.2 ±1 %.		42.9 ±1 %.		3.6 ±1 %.	
1800	72.0 ±1 %.		41.7 ±1 %.		3.6 ±1 %.	
1900	68.0 ±1 %.		39.5 ±1 %.		3.6 ±1 %.	
1950	66.3 ±1 %.		38.5 ±1 %.		3.6 ±1 %.	
2000	64.5 ±1 %.		37.5 ±1 %.		3.6 ±1 %.	
2100	61.0 ±1 %.		35.7 ±1 %.		3.6 ±1 %.	
2300	55.5 ±1 %.		32.6 ±1 %.		3.6 ±1 %.	
2450	51.5 ±1 %.		30.4 ±1 %.		3.6 ±1 %.	
2600	48.5 ±1 %.		28.8 ±1 %.		3.6 ±1 %.	
3000	41.5 ±1 %.		25.0 ±1 %.		3.6 ±1 %.	
3500	37.0 ±1 %.		26.4 ±1 %.		3.6 ±1 %.	
3700	34.7 ±1 %.		26.4 ±1 %.		3.6 ±1 %.	

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SAR REFERENCE DIPOLE CALIBRATION REPORT

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7 VALIDATION MEASUREMENT

The IEEE Std. 1528, OET 65 Bulletin C and CEI/IEC 62209 standards state that the system validation measurements must be performed using a reference dipole meeting the fore mentioned return loss and mechanical dimension requirements. The validation measurement must be performed against a liquid filled flat phantom, with the phantom constructed as outlined in the fore mentioned standards. Per the standards, the dipole shall be positioned below the bottom of the phantom, with the dipole length centered and parallel to the longest dimension of the flat phantom, with the top surface of the dipole at the described distance from the bottom surface of the phantom.

7.1 MEASUREMENT CONDITION

Software	OPENSAR V4
Phantom	SN 20/09 SAM71
Probe	SN 18/11 EPG122
Liquid	Head Liquid Values: eps' : 43.0 sigma : 0.88
Distance between dipole center and liquid	15.0 mm
Area scan resolution	dx=8mm/dy=8mm
Zoon Scan Resolution	dx=8mm/dy=8m/dz=5mm
Frequency	835 MHz
Input power	20 dBm
Liquid Temperature	21 °C
Lab Temperature	21 °C
Lab Humidity	45 %

7.2 HEAD LIQUID MEASUREMENT

Frequency MHz	Relative permittivity (ϵ_r')		Conductivity (σ) S/m	
	required	measured	required	measured
300	45.3 ± 5 %		0.87 ± 5 %	
450	43.5 ± 5 %		0.87 ± 5 %	
750	41.9 ± 5 %		0.89 ± 5 %	
835	41.5 ± 5 %	PASS	0.90 ± 5 %	PASS
900	41.5 ± 5 %		0.97 ± 5 %	
1450	40.5 ± 5 %		1.20 ± 5 %	
1500	40.4 ± 5 %		1.23 ± 5 %	
1640	40.2 ± 5 %		1.31 ± 5 %	
1750	40.1 ± 5 %		1.37 ± 5 %	
1800	40.0 ± 5 %		1.40 ± 5 %	
1900	40.0 ± 5 %		1.40 ± 5 %	
1950	40.0 ± 5 %		1.40 ± 5 %	
2000	40.0 ± 5 %		1.40 ± 5 %	
2100	39.8 ± 5 %		1.49 ± 5 %	
2300	39.5 ± 5 %		1.67 ± 5 %	
2450	39.2 ± 5 %		1.80 ± 5 %	
2600	39.0 ± 5 %		1.96 ± 5 %	
3000	38.5 ± 5 %		2.40 ± 5 %	
3500	37.9 ± 5 %		2.91 ± 5 %	

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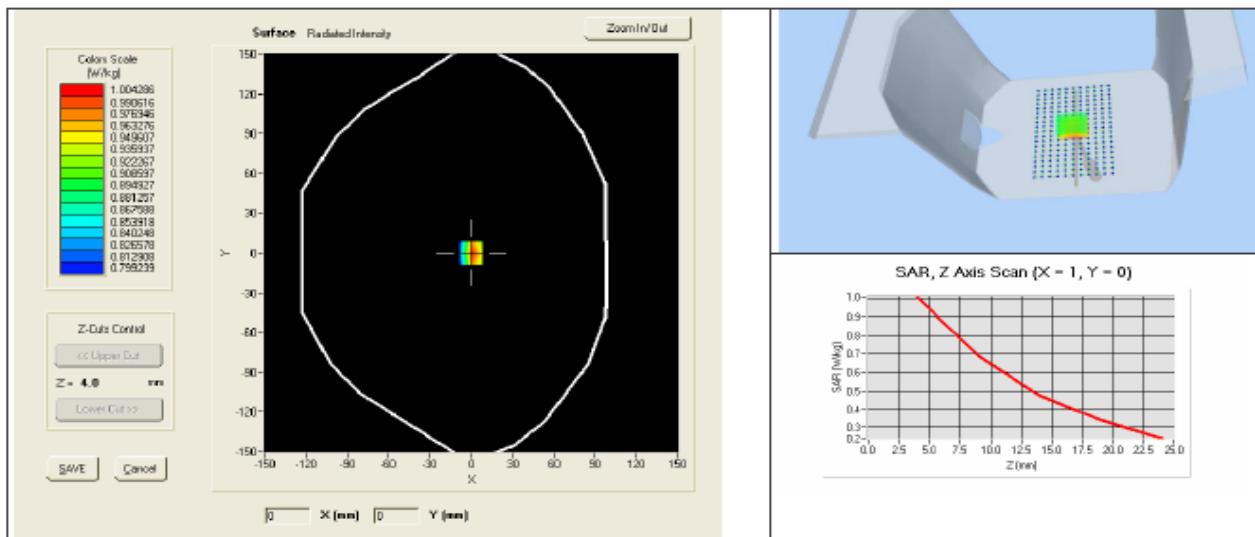
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7.3 MEASUREMENT RESULT

The IEEE Std. 1528 and CEI/IEC 62209 standards state that the system validation measurements should produce the SAR values shown below (for phantom thickness of 2 mm), within the uncertainty for the system validation. All SAR values are normalized to 1 W forward power. In bracket, the measured SAR is given with the used input power.

Frequency MHz	1 g SAR (W/kg/W)		10 g SAR (W/kg/W)	
	required	measured	required	measured
300	2.85		1.94	
450	4.58		3.06	
750	8.49		5.55	
835	9.56	9.59 (0.96)	6.22	6.25 (0.62)
900	10.9		6.99	
1450	29		16	
1500	30.5		16.8	
1640	34.2		18.4	
1750	36.4		19.3	
1800	38.4		20.1	
1900	39.7		20.5	
1950	40.5		20.9	
2000	41.1		21.1	
2100	43.6		21.9	
2300	48.7		23.3	
2450	52.4		24	
2600	55.3		24.6	
3000	63.8		25.7	
3500	67.1		25	



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8 LIST OF EQUIPMENT**Equipment Summary Sheet**

Equipment Description	Manufacturer / Model	Identification No.	Current Calibration Date	Next Calibration Date
Flat Phantom	Satimo	SN-20/09-SAM71	Validated. No cal required.	Validated. No cal required.
COMOSAR Test Bench	Version 3	NA	Validated. No cal required.	Validated. No cal required.
Network Analyzer	Rhode & Schwarz ZVA	SN100132	02/2010	02/2013
Calipers	Carrera	CALIPER-01	12/2010	12/2013
Reference Probe	Satimo	EPG122 SN 18/11	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Multimeter	Keithley 2000	1188656	11/2010	11/2013
Signal Generator	Agilent E4438C	MY49070581	12/2010	12/2013
Amplifier	Aethercomm	SN 046	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Power Meter	HP E4418A	US38261498	11/2010	11/2013
Power Sensor	HP ECP-E26A	US37181460	11/2010	11/2013
Directional Coupler	Narda 4216-20	01386	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Temperature and Humidity Sensor	Control Company	11-661-9	3/2010	3/2012



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SAR Reference Dipole Calibration Report

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SCIENCE AND TECHNOLOGY PARK
NAN SHAN DISTRICT, SHENZHEN 518057 , GUANGDONG
,P.R.C.**

SATIMO COMOSAR REFERENCE DIPOLE

Calibrated at SATIMO US

2105 Barrett Park Dr. - Kennesaw, GA 30144



06/01/2011

Summary:

This document presents the method and results from an accredited SAR reference dipole calibration performed in SATIMO USA using the COMOSAR test bench. All calibration results are traceable to national metrology institutions.

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Ref: ACR.158.7.11.SATU.A

	Name	Function	Date	Signature
Prepared by :	Jérôme LUC	Product Manager	6/7/2011	
Checked by :	Jérôme LUC	Product Manager	6/7/2011	
Approved by :	Kim RUTKOWSKI	Quality Manager	6/7/2011	Kim Rutkowski

Distribution :	Customer Name
	SIEMIC Testing and Certification Services

Issue	Date	Modifications
A	6/7/2011	Initial release



SAR REFERENCE DIPOLE CALIBRATION REPORT

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7.3	Measurement Result	8
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**SAR REFERENCE DIPOLE CALIBRATION REPORT**

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1 INTRODUCTION

This document contains a summary of the requirements set forth by the IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards for reference dipoles used for SAR measurement system validations and the measurements that were performed to verify that the product complies with the fore mentioned standards.

2 DEVICE UNDER TEST

Device Under Test	
Device Type	COMOSAR 1900 MHz REFERENCE DIPOLE
Manufacturer	Satimo
Model	SID1900
Serial Number	SN 18/11 DIPG153
Product Condition (new / used)	new

A yearly calibration interval is recommended.

3 PRODUCT DESCRIPTION**3.1 GENERAL INFORMATION**

Satimo's COMOSAR Validation Dipoles are built in accordance to the IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards. The product is designed for use with the COMOSAR test bench only.



Figure 1 – Satimo COMOSAR Validation Dipole



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4 MEASUREMENT METHOD

The IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards provide requirements for reference dipoles used for system validation measurements. The following measurements were performed to verify that the product complies with the fore mentioned standards.

4.1 RETURN LOSS REQUIREMENTS

The dipole used for SAR system validation measurements and checks must have a return loss of -20 dB or better. The return loss measurement shall be performed against a liquid filled flat phantom, with the phantom constructed as outlined in the fore mentioned standards.

4.2 MECHANICAL REQUIREMENTS

The IEEE Std. 1528 and CEI/IEC 62209 standards specify the mechanical components and dimensions of the validation dipoles, with the dimensions frequency and phantom shell thickness dependent. The COMOSAR test bench employs a 2 mm phantom shell thickness therefore the dipoles sold for use with the COMOSAR test bench comply with the requirements set forth for a 2 mm phantom shell thickness.

5 MEASUREMENT UNCERTAINTY

All uncertainties listed below represent an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2, traceable to the Internationally Accepted Guides to Measurement Uncertainty.

5.1 RETURN LOSS

The following uncertainties apply to the return loss measurement:

Frequency band	Expanded Uncertainty on Return Loss
400-6000MHz	0.1 dB

5.2 DIMENSION MEASUREMENT

The following uncertainties apply to the dimension measurements:

Length (mm)	Expanded Uncertainty on Length
3 - 300	0.05 mm

5.3 VALIDATION MEASUREMENT

The guidelines outlined in the IEEE 1528, OET 65 Bulletin C, CENELEC EN50361 and CEI/IEC 62209 standards were followed to generate the measurement uncertainty for validation measurements.

Scan Volume	Expanded Uncertainty
1 g	16.19 %
10 g	15.86 %

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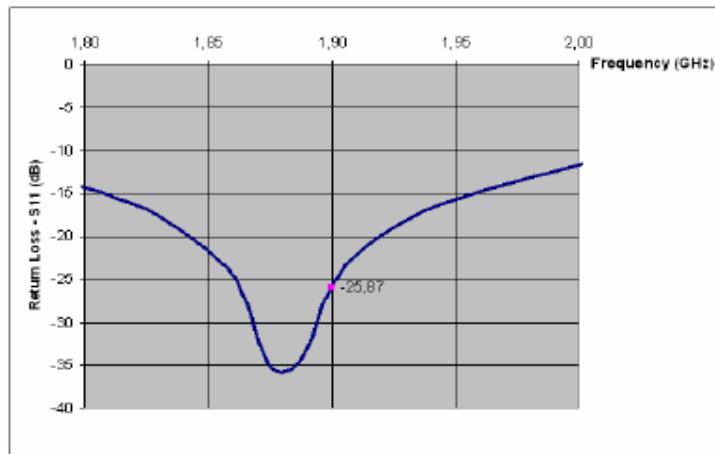
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6 CALIBRATION MEASUREMENT RESULTS

6.1 RETURN LOSS6.2 MECHANICAL DIMENSIONS

Frequency MHz	L mm		h mm		d mm	
	required	measured	required	measured	required	measured
300	420.0 ±1 %.		250.0 ±1 %.		6.35 ±1 %.	
450	290.0 ±1 %.		166.7 ±1 %.		6.35 ±1 %.	
750	176.0 ±1 %.		100.0 ±1 %.		6.35 ±1 %.	
835	161.0 ±1 %.		89.8 ±1 %.		3.6 ±1 %.	
900	149.0 ±1 %.		83.3 ±1 %.		3.6 ±1 %.	
1450	89.1 ±1 %.		51.7 ±1 %.		3.6 ±1 %.	
1500	80.5 ±1 %.		50.0 ±1 %.		3.6 ±1 %.	
1640	79.0 ±1 %.		45.7 ±1 %.		3.6 ±1 %.	
1750	75.2 ±1 %.		42.9 ±1 %.		3.6 ±1 %.	
1800	72.0 ±1 %.		41.7 ±1 %.		3.6 ±1 %.	
1900	68.0 ±1 %.	PASS	39.5 ±1 %.	PASS	3.6 ±1 %.	PASS
1950	66.3 ±1 %.		38.5 ±1 %.		3.6 ±1 %.	
2000	64.5 ±1 %.		37.5 ±1 %.		3.6 ±1 %.	
2100	61.0 ±1 %.		35.7 ±1 %.		3.6 ±1 %.	
2300	55.5 ±1 %.		32.6 ±1 %.		3.6 ±1 %.	
2450	51.5 ±1 %.		30.4 ±1 %.		3.6 ±1 %.	
2600	48.5 ±1 %.		28.8 ±1 %.		3.6 ±1 %.	
3000	41.5 ±1 %.		25.0 ±1 %.		3.6 ±1 %.	
3500	37.0 ±1 %.		26.4 ±1 %.		3.6 ±1 %.	
3700	34.7 ±1 %.		26.4 ±1 %.		3.6 ±1 %.	



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7 VALIDATION MEASUREMENT

The IEEE Std. 1528, OET 65 Bulletin C and CEI/IEC 62209 standards state that the system validation measurements must be performed using a reference dipole meeting the fore mentioned return loss and mechanical dimension requirements. The validation measurement must be performed against a liquid filled flat phantom, with the phantom constructed as outlined in the fore mentioned standards. Per the standards, the dipole shall be positioned below the bottom of the phantom, with the dipole length centered and parallel to the longest dimension of the flat phantom, with the top surface of the dipole at the described distance from the bottom surface of the phantom.

7.1 MEASUREMENT CONDITION

Software	OPENSAR V4
Phantom	SN 20/09 SAM71
Probe	SN 18/11 EPG122
Liquid	Head Liquid Values: ϵ_r' : 38.5 sigma : 1.42
Distance between dipole center and liquid	10.0 mm
Area scan resolution	$dx=8mm/dy=8mm$
Zoon Scan Resolution	$dx=8mm/dy=8m/dz=5mm$
Frequency	1900 MHz
Input power	20 dBm
Liquid Temperature	21 °C
Lab Temperature	21 °C
Lab Humidity	45 %

7.2 HEAD LIQUID MEASUREMENT

Frequency MHz	Relative permittivity (ϵ_r')		Conductivity (σ) S/m	
	required	measured	required	measured
300	45.3 ±5 %		0.87 ±5 %	
450	43.5 ±5 %		0.87 ±5 %	
750	41.9 ±5 %		0.89 ±5 %	
835	41.5 ±5 %		0.90 ±5 %	
900	41.5 ±5 %		0.97 ±5 %	
1450	40.5 ±5 %		1.20 ±5 %	
1500	40.4 ±5 %		1.23 ±5 %	
1640	40.2 ±5 %		1.31 ±5 %	
1750	40.1 ±5 %		1.37 ±5 %	
1800	40.0 ±5 %		1.40 ±5 %	
1900	40.0 ±5 %	PASS	1.40 ±5 %	PASS
1950	40.0 ±5 %		1.40 ±5 %	
2000	40.0 ±5 %		1.40 ±5 %	
2100	39.8 ±5 %		1.49 ±5 %	
2300	39.5 ±5 %		1.67 ±5 %	
2450	39.2 ±5 %		1.80 ±5 %	
2600	39.0 ±5 %		1.96 ±5 %	
3000	38.5 ±5 %		2.40 ±5 %	
3500	37.9 ±5 %		2.91 ±5 %	

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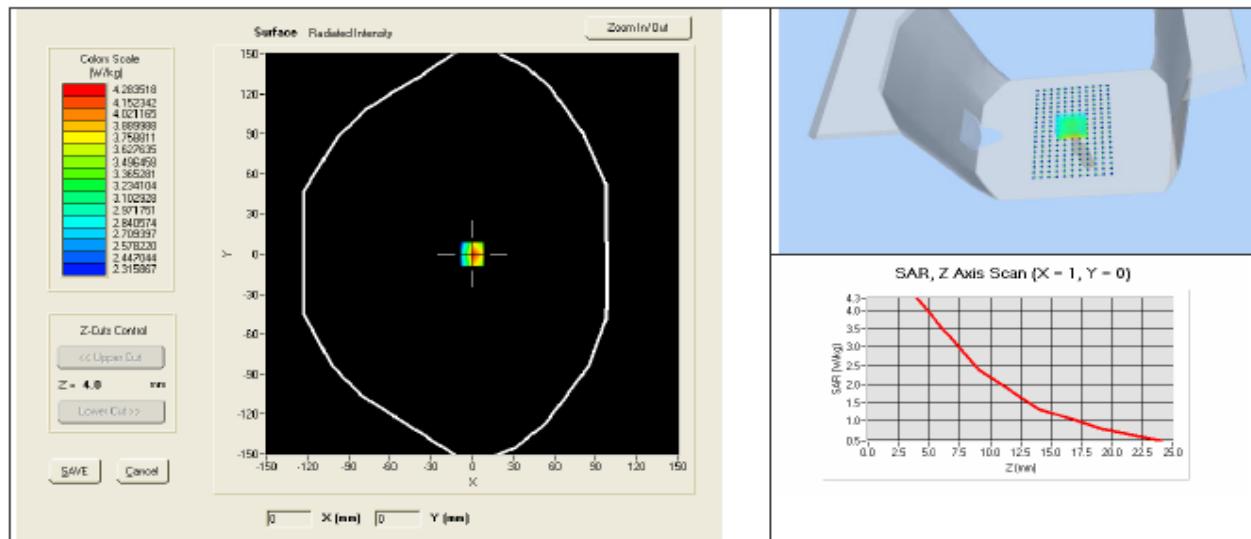
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Ref: ACR.158.7.11.SATU.A

7.3 MEASUREMENT RESULT

The IEEE Std. 1528 and CEI/IEC 62209 standards state that the system validation measurements should produce the SAR values shown below (for phantom thickness of 2 mm), within the uncertainty for the system validation. All SAR values are normalized to 1 W forward power. In bracket, the measured SAR is given with the used input power.

Frequency MHz	1 g SAR (W/kg/W)		10 g SAR (W/kg/W)	
	required	measured	required	measured
300	2.85		1.94	
450	4.58		3.06	
750	8.49		5.55	
835	9.56		6.22	
900	10.9		6.99	
1450	29		16	
1500	30.5		16.8	
1640	34.2		18.4	
1750	36.4		19.3	
1800	38.4		20.1	
1900	39.7	39.92 (3.99)	20.5	20.49 (2.05)
1950	40.5		20.9	
2000	41.1		21.1	
2100	43.6		21.9	
2300	48.7		23.3	
2450	52.4		24	
2600	55.3		24.6	
3000	63.8		25.7	
3500	67.1		25	



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8 LIST OF EQUIPMENT**Equipment Summary Sheet**

Equipment Description	Manufacturer / Model	Identification No.	Current Calibration Date	Next Calibration Date
Flat Phantom	Satimo	SN-20/09-SAM71	Validated. No cal required.	Validated. No cal required.
COMOSAR Test Bench	Version 3	NA	Validated. No cal required.	Validated. No cal required.
Network Analyzer	Rhode & Schwarz ZVA	SN100132	02/2010	02/2013
Calipers	Carrera	CALIPER-01	12/2010	12/2013
Reference Probe	Satimo	EPG122 SN 18/11	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Multimeter	Keithley 2000	1188656	11/2010	11/2013
Signal Generator	Agilent E4438C	MY49070581	12/2010	12/2013
Amplifier	Aethercomm	SN 046	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Power Meter	HP E4418A	US38261498	11/2010	11/2013
Power Sensor	HP ECP-E26A	US37181460	11/2010	11/2013
Directional Coupler	Narda 4216-20	01386	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Temperature and Humidity Sensor	Control Company	11-661-9	3/2010	3/2012

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**SAR Reference Dipole Calibration Report**

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SIEMIC TESTING AND CERTIFICATION SERVICES

**SUITE 311, BUILDING 1, SECTION 30 ,NO.2 KEFA ROAD,
SCIENCE AND TECHNOLOGY PARK
NAN SHAN DISTRICT, SHENZHEN 518057 , GUANGDONG
,P.R.C.**

SATIMO COMOSAR REFERENCE DIPOLE

Calibrated at SATIMO US

2105 Barrett Park Dr. - Kennesaw, GA 30144



06/01/2011

Summary:

This document presents the method and results from an accredited SAR reference dipole calibration performed in SATIMO USA using the COMOSAR test bench. All calibration results are traceable to national metrology institutions.

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	Name	Function	Date	Signature
Prepared by :	Jérôme LUC	Product Manager	6/7/2011	
Checked by :	Jérôme LUC	Product Manager	6/7/2011	
Approved by :	Kim RUTKOWSKI	Quality Manager	6/7/2011	

Distribution :	Customer Name
	SIEMIC Testing and Certification Services

Issue	Date	Modifications
A	6/7/2011	Initial release



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1 INTRODUCTION

This document contains a summary of the requirements set forth by the IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards for reference dipoles used for SAR measurement system validations and the measurements that were performed to verify that the product complies with the fore mentioned standards.

2 DEVICE UNDER TEST

Device Under Test	
Device Type	COMOSAR 2450 MHz REFERENCE DIPOLE
Manufacturer	Satimo
Model	SID2450
Serial Number	SN 18/11 DIPJ155
Product Condition (new / used)	new

A yearly calibration interval is recommended.

3 PRODUCT DESCRIPTION**3.1 GENERAL INFORMATION**

Satimo's COMOSAR Validation Dipoles are built in accordance to the IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards. The product is designed for use with the COMOSAR test bench only.



Figure 1 – Satimo COMOSAR Validation Dipole



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4 MEASUREMENT METHOD

The IEEE 1528, OET 65 Bulletin C and CEI/IEC 62209 standards provide requirements for reference dipoles used for system validation measurements. The following measurements were performed to verify that the product complies with the fore mentioned standards.

4.1 RETURN LOSS REQUIREMENTS

The dipole used for SAR system validation measurements and checks must have a return loss of -20 dB or better. The return loss measurement shall be performed against a liquid filled flat phantom, with the phantom constructed as outlined in the fore mentioned standards.

4.2 MECHANICAL REQUIREMENTS

The IEEE Std. 1528 and CEI/IEC 62209 standards specify the mechanical components and dimensions of the validation dipoles, with the dimensions frequency and phantom shell thickness dependent. The COMOSAR test bench employs a 2 mm phantom shell thickness therefore the dipoles sold for use with the COMOSAR test bench comply with the requirements set forth for a 2 mm phantom shell thickness.

5 MEASUREMENT UNCERTAINTY

All uncertainties listed below represent an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of k=2, traceable to the Internationally Accepted Guides to Measurement Uncertainty.

5.1 RETURN LOSS

The following uncertainties apply to the return loss measurement:

Frequency band	Expanded Uncertainty on Return Loss
400-6000MHz	0.1 dB

5.2 DIMENSION MEASUREMENT

The following uncertainties apply to the dimension measurements:

Length (mm)	Expanded Uncertainty on Length
3 - 300	0.05 mm

5.3 VALIDATION MEASUREMENT

The guidelines outlined in the IEEE 1528, OET 65 Bulletin C, CENELEC EN50361 and CEI/IEC 62209 standards were followed to generate the measurement uncertainty for validation measurements.

Scan Volume	Expanded Uncertainty
1 g	16.19 %
10 g	15.86 %



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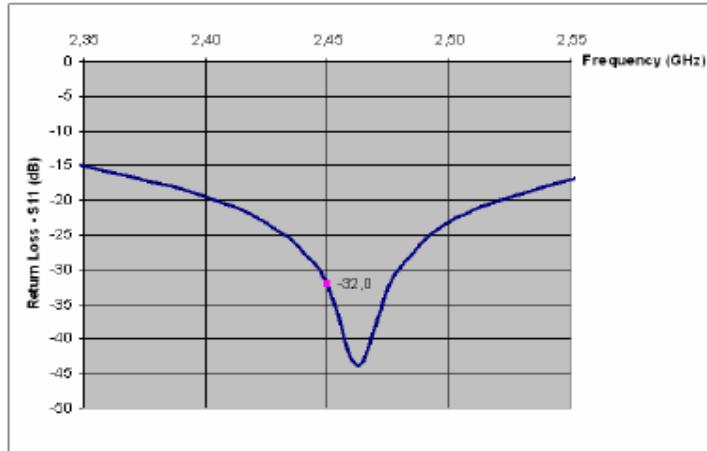


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6 CALIBRATION MEASUREMENT RESULTS

6.1 RETURN LOSS



Frequency (MHz)	Return Loss (dB)	Requirement (dB)
2450	-32.00	-20

6.2 MECHANICAL DIMENSIONS

Frequency MHz	L mm		h mm		d mm	
	required	measured	required	measured	required	measured
300	420.0 ±1 %.		250.0 ±1 %.		6.35 ±1 %.	
450	290.0 ±1 %.		166.7 ±1 %.		6.35 ±1 %.	
750	176.0 ±1 %.		100.0 ±1 %.		6.35 ±1 %.	
835	161.0 ±1 %.		89.8 ±1 %.		3.6 ±1 %.	
900	149.0 ±1 %.		83.3 ±1 %.		3.6 ±1 %.	
1450	89.1 ±1 %.		51.7 ±1 %.		3.6 ±1 %.	
1500	80.5 ±1 %.		50.0 ±1 %.		3.6 ±1 %.	
1640	79.0 ±1 %.		45.7 ±1 %.		3.6 ±1 %.	
1750	75.2 ±1 %.		42.9 ±1 %.		3.6 ±1 %.	
1800	72.0 ±1 %.		41.7 ±1 %.		3.6 ±1 %.	
1900	68.0 ±1 %.		39.5 ±1 %.		3.6 ±1 %.	
1950	66.3 ±1 %.		38.5 ±1 %.		3.6 ±1 %.	
2000	64.5 ±1 %.		37.5 ±1 %.		3.6 ±1 %.	
2100	61.0 ±1 %.		35.7 ±1 %.		3.6 ±1 %.	
2300	55.5 ±1 %.		32.6 ±1 %.		3.6 ±1 %.	
2450	51.5 ±1 %.	PASS	30.4 ±1 %.	PASS	3.6 ±1 %.	PASS
2600	48.5 ±1 %.		28.8 ±1 %.		3.6 ±1 %.	
3000	41.5 ±1 %.		25.0 ±1 %.		3.6 ±1 %.	
3500	37.0 ±1 %.		26.4 ±1 %.		3.6 ±1 %.	
3700	34.7 ±1 %.		26.4 ±1 %.		3.6 ±1 %.	

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7 VALIDATION MEASUREMENT

The IEEE Std. 1528, OET 65 Bulletin C and CEI/IEC 62209 standards state that the system validation measurements must be performed using a reference dipole meeting the fore mentioned return loss and mechanical dimension requirements. The validation measurement must be performed against a liquid filled flat phantom, with the phantom constructed as outlined in the fore mentioned standards. Per the standards, the dipole shall be positioned below the bottom of the phantom, with the dipole length centered and parallel to the longest dimension of the flat phantom, with the top surface of the dipole at the described distance from the bottom surface of the phantom.

7.1 MEASUREMENT CONDITION

Software	OPENSAR V4
Phantom	SN 20/09 SAM71
Probe	SN 18/11 EPG122
Liquid	Head Liquid Values: ϵ_s' : 38.8 sigma : 1.88
Distance between dipole center and liquid	10.0 mm
Area scan resolution	$dx=8mm/dy=8mm$
Zoon Scan Resolution	$dx=8mm/dy=8m/dz=5mm$
Frequency	2450 MHz
Input power	20 dBm
Liquid Temperature	21 °C
Lab Temperature	21 °C
Lab Humidity	45 %

7.2 HEAD LIQUID MEASUREMENT

Frequency MHz	Relative permittivity (ϵ_r')		Conductivity (σ) S/m	
	required	measured	required	measured
300	45.3 ± 5 %		0.87 ± 5 %	
450	43.5 ± 5 %		0.87 ± 5 %	
750	41.9 ± 5 %		0.89 ± 5 %	
835	41.5 ± 5 %		0.90 ± 5 %	
900	41.5 ± 5 %		0.97 ± 5 %	
1450	40.5 ± 5 %		1.20 ± 5 %	
1500	40.4 ± 5 %		1.23 ± 5 %	
1640	40.2 ± 5 %		1.31 ± 5 %	
1750	40.1 ± 5 %		1.37 ± 5 %	
1800	40.0 ± 5 %		1.40 ± 5 %	
1900	40.0 ± 5 %		1.40 ± 5 %	
1950	40.0 ± 5 %		1.40 ± 5 %	
2000	40.0 ± 5 %		1.40 ± 5 %	
2100	39.8 ± 5 %		1.49 ± 5 %	
2300	39.5 ± 5 %		1.67 ± 5 %	
2450	39.2 ± 5 %	PASS	1.80 ± 5 %	PASS
2600	39.0 ± 5 %		1.96 ± 5 %	
3000	38.5 ± 5 %		2.40 ± 5 %	
3500	37.9 ± 5 %		2.91 ± 5 %	

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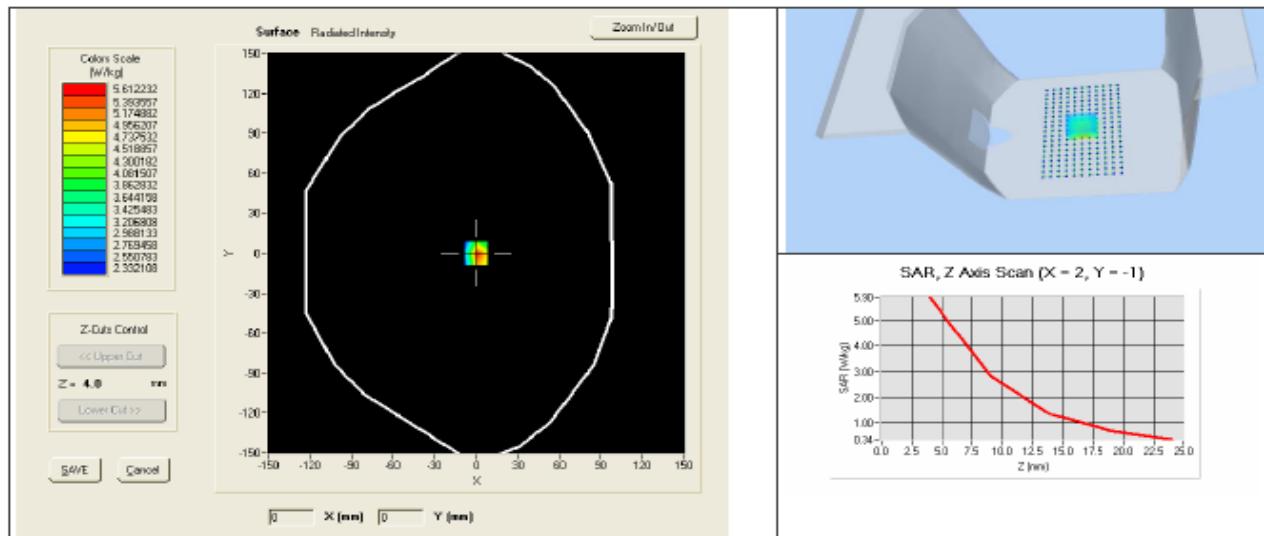
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7.3 MEASUREMENT RESULT

The IEEE Std. 1528 and CEI/IEC 62209 standards state that the system validation measurements should produce the SAR values shown below (for phantom thickness of 2 mm), within the uncertainty for the system validation. All SAR values are normalized to 1 W forward power. In bracket, the measured SAR is given with the used input power.

Frequency MHz	1 g SAR (W/kg/W)		10 g SAR (W/kg/W)	
	required	measured	required	measured
300	2.85		1.94	
450	4.58		3.06	
750	8.49		5.55	
835	9.56		6.22	
900	10.9		6.99	
1450	29		16	
1500	30.5		16.8	
1640	34.2		18.4	
1750	36.4		19.3	
1800	38.4		20.1	
1900	39.7		20.5	
1950	40.5		20.9	
2000	41.1		21.1	
2100	43.6		21.9	
2300	48.7		23.3	
2450	52.4	53.82 (5.38)	24	24.12 (2.41)
2600	55.3		24.6	
3000	63.8		25.7	
3500	67.1		25	



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8 LIST OF EQUIPMENT**Equipment Summary Sheet**

Equipment Description	Manufacturer / Model	Identification No.	Current Calibration Date	Next Calibration Date
Flat Phantom	Satimo	SN-20/09-SAM71	Validated. No cal required.	Validated. No cal required.
COMOSAR Test Bench	Version 3	NA	Validated. No cal required.	Validated. No cal required.
Network Analyzer	Rhode & Schwarz ZVA	SN100132	02/2010	02/2013
Calipers	Carrera	CALIPER-01	12/2010	12/2013
Reference Probe	Satimo	EPG122 SN 18/11	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Multimeter	Keithley 2000	1188656	11/2010	11/2013
Signal Generator	Agilent E4438C	MY49070581	12/2010	12/2013
Amplifier	Aethercomm	SN 046	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Power Meter	HP E4418A	US38261498	11/2010	11/2013
Power Sensor	HP ECP-E26A	US37181460	11/2010	11/2013
Directional Coupler	Narda 4216-20	01386	Characterized prior to test. No cal required.	Characterized prior to test. No cal required.
Temperature and Humidity Sensor	Control Company	11-661-9	3/2010	3/2012



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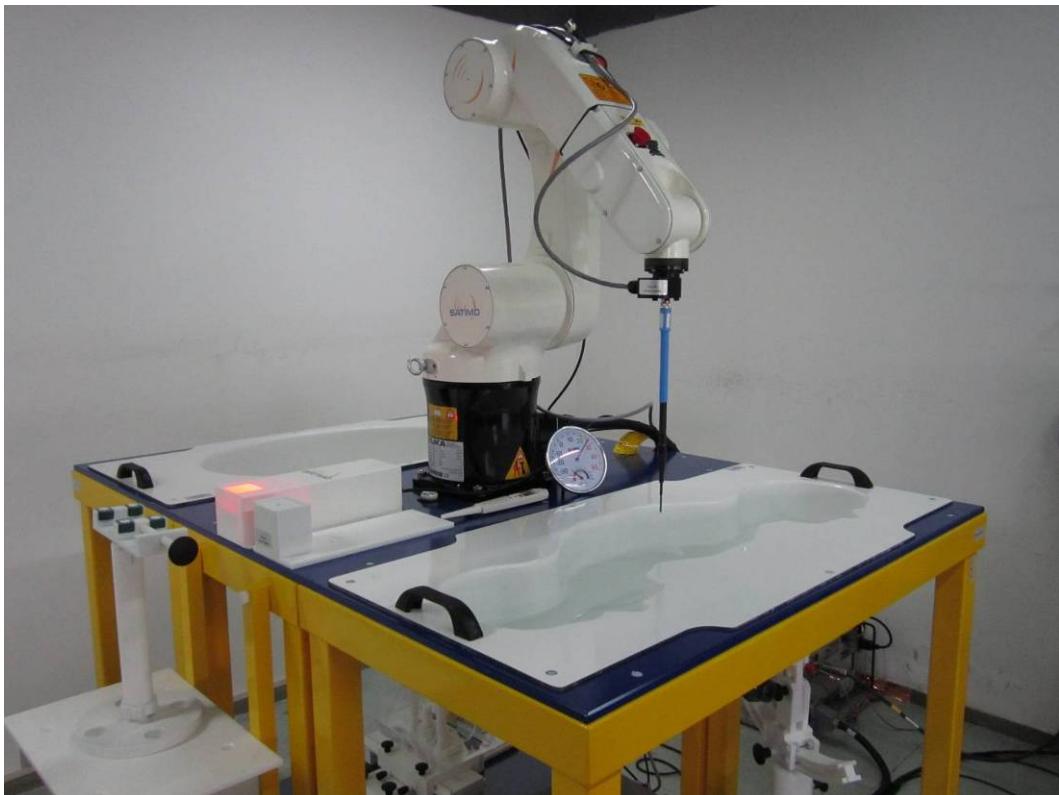
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Annex C SAR System PHOTOGRAPHS



Liquid depth \geq 15cm



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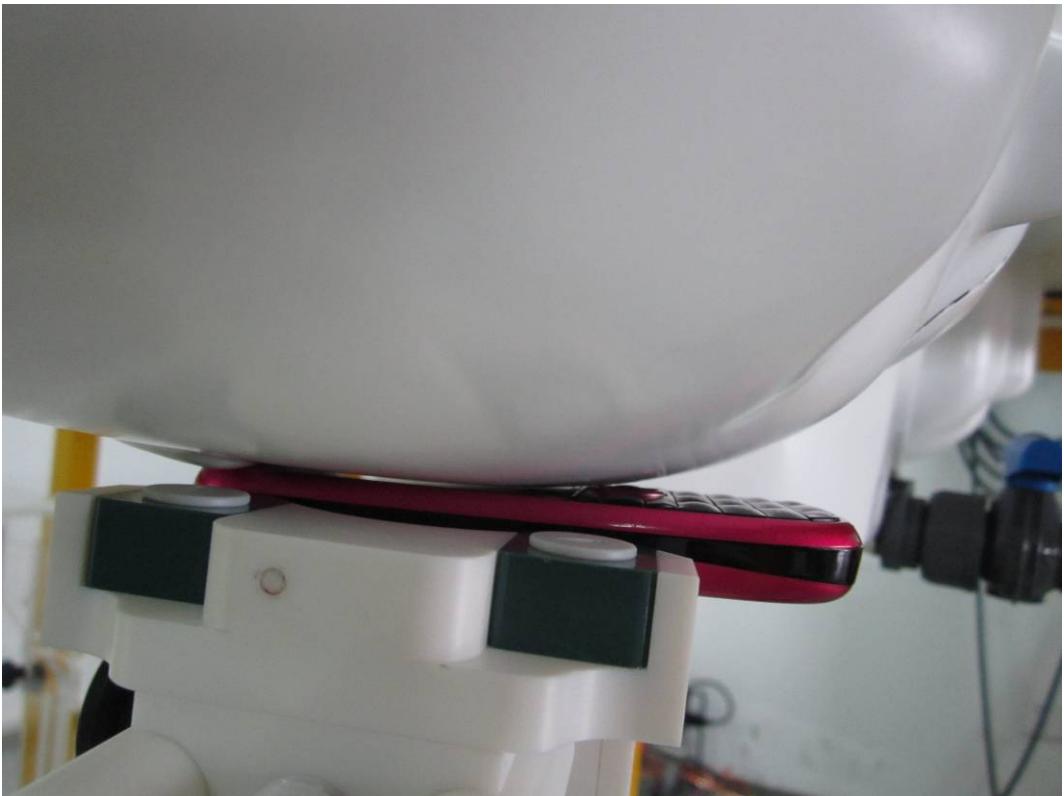
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Annex D SETUP PHOTOGRAPHS

Right Head Touch View



Right Head Tilt View





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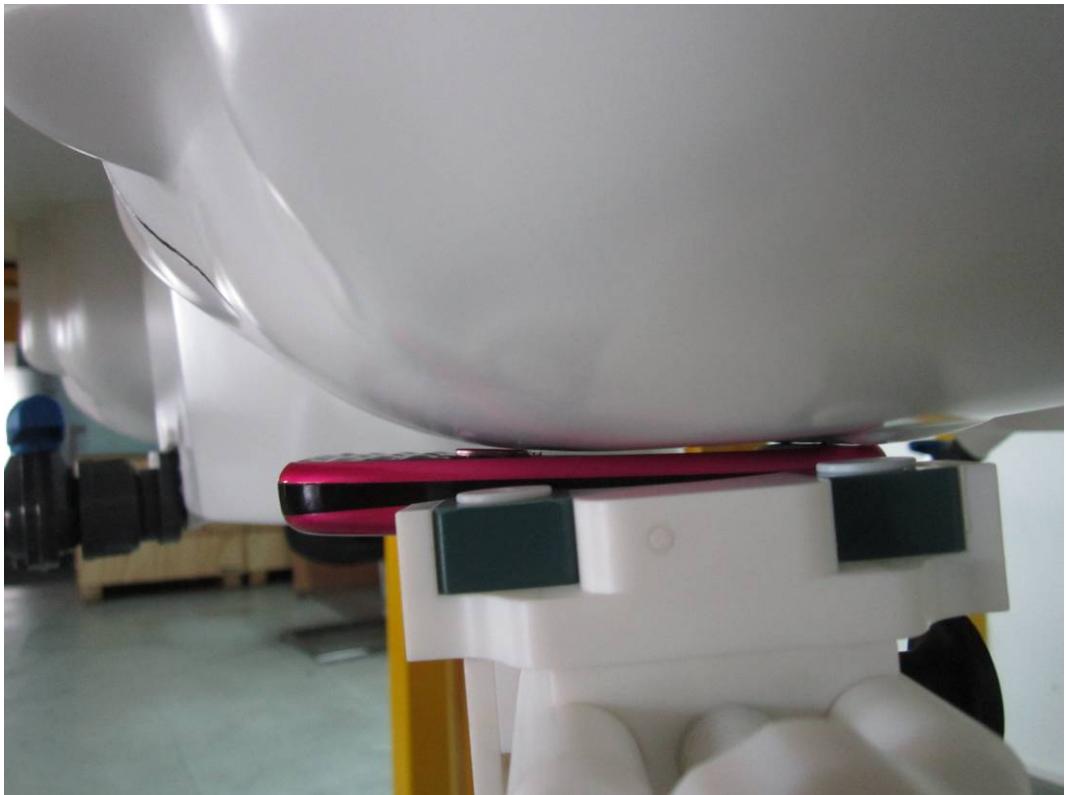
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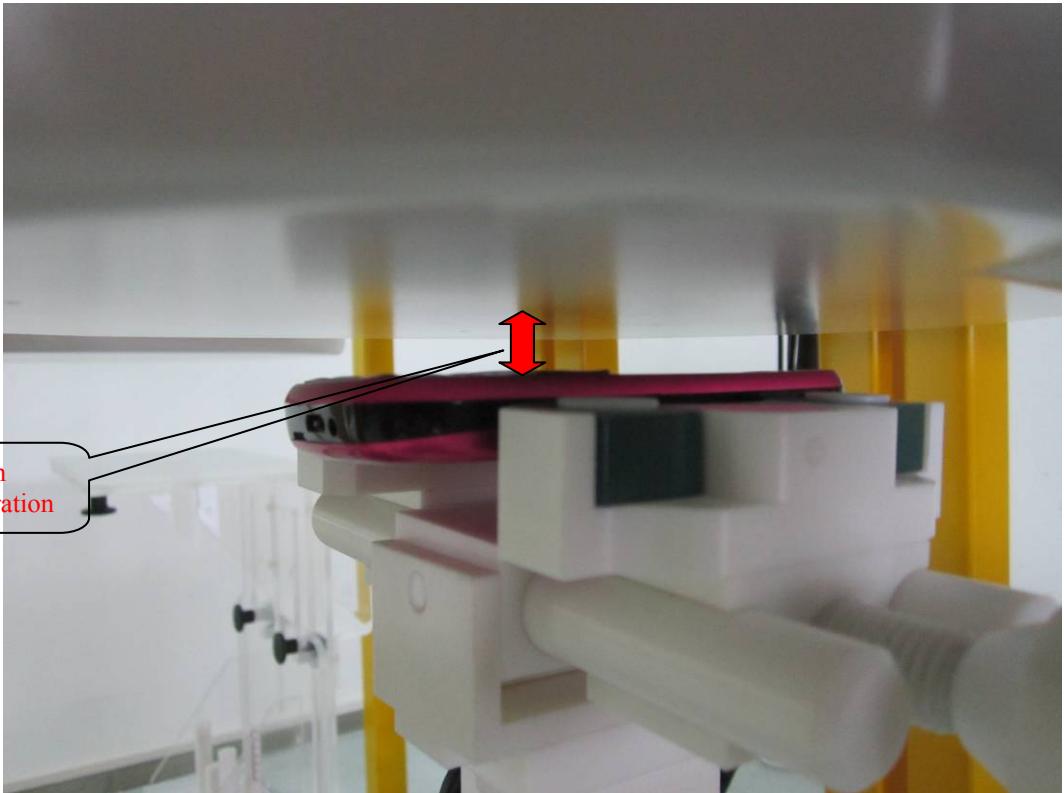
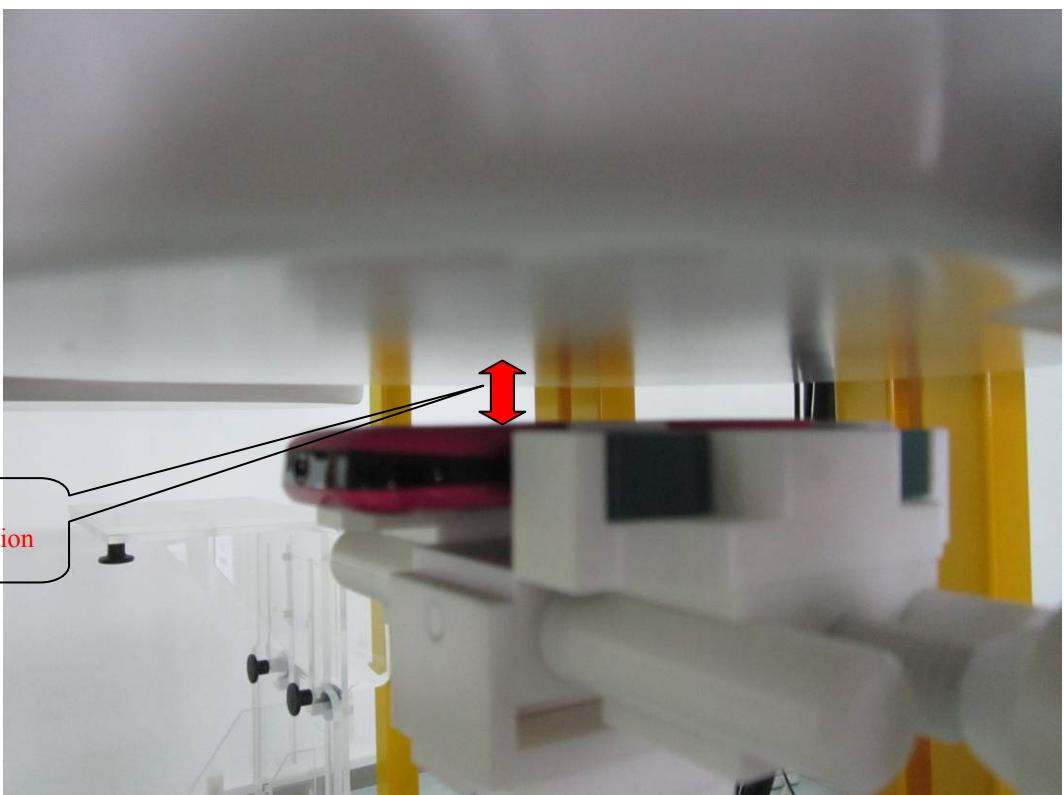
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Left Head Touch View



Left Head Tilt View



Body Setup Photo (LCD UP)**Body Setup Photo (LCD DOWN)**



Annex E EUT PHOTO

EUT-Front Side View



EUT-Back Side View



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EUT-Battery Uncover View**EUT-Bottom Side View**



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EUT-Top Side View

